

Planar THz Devices and Graphene Tunnelling Diodes

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Acknowledgements

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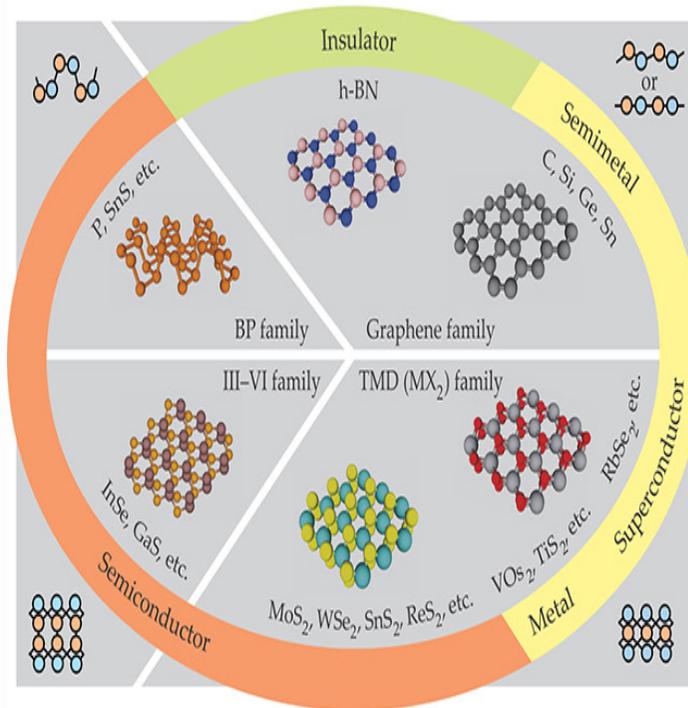
Planar THz Devices and Graphene Tunnelling Diodes

- 
- ❖ **Background**
 - ❖ **How to determine 2D material thickness**
 - ❖ **Graphene tunnelling transistors**
 - ❖ **Planar THz nanodevices**
 - ❖ **Semiconducting graphene nanoribbons**
 - ❖ **Summary**

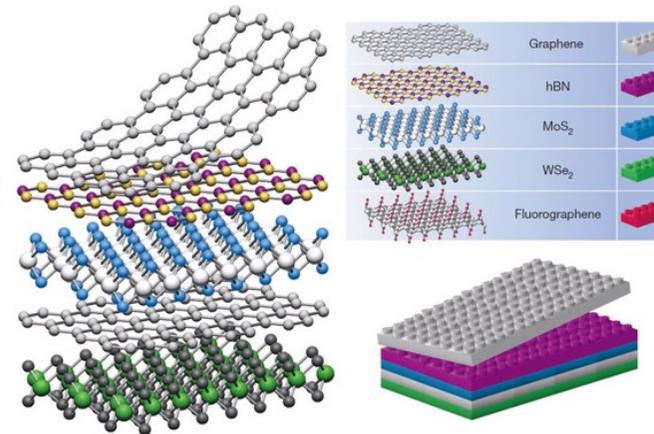
Graphene: A Super Material

- Nobel Prize in Physics 2010
- Thinnest imaginable material
- Strongest material ever measured (theoretical limit)
- Stiffest known material (stiffer than diamond)
- Most stretchable crystal (up to 20% elastically)
- Record thermal conductivity (outperforming diamond)
- Highest current density at room T (million times of that in copper)
- Lightest charge carriers (zero rest mass)
- Most impermeable (even He atoms cannot squeeze through)
- Highest intrinsic mobility (>100 times that of Silicon)
- Longest mean free path at room temperature (micron range)

2D materials: a huge family



Graphene family	Graphene	hBN 'white graphene'	BCN	Fluorographene	Graphene oxide
2D chalcogenides	MoS ₂ , WS ₂ , MoSe ₂ , WSe ₂		Semiconducting dichalcogenides: MoTe ₂ , WTe ₂ , ZrS ₂ , ZrSe ₂ , and so on		Metallic dichalcogenides: NbSe ₂ , NbS ₂ , TaS ₂ , TiS ₂ , NiSe ₂ and so on
					Layered semiconductors: GaSe, GaTe, InSe, Bi ₂ Se ₃ and so on
2D oxides	Micas, BSCCO	MoO ₃ , WO ₃	Perovskite-type: LaNb ₂ O ₇ , (Ca,Sr) ₂ Nb ₂ O ₁₀ , Bi ₄ Ti ₃ O ₁₂ , Ca ₂ Ta ₂ TiO ₁₀ and so on		Hydroxides: Ni(OH) ₂ , Eu(OH) ₂ and so on
	Layered Cu oxides	TiO ₂ , MnO ₂ , V ₂ O ₅ , TaO ₂ , RuO ₂ and so on			Others



More than 1800 types of 2D materials

Nature Nanotech 5, 487–496 (2010).
Nature 490, 192–200 (2012)
Nature 499, 419–425 (2013).

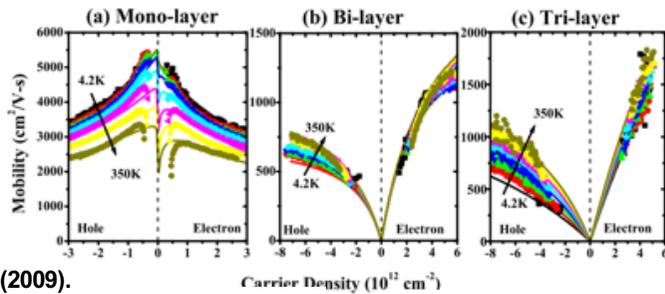
2D materials: Problem 1

Too thin!

Difficult to identify atomic layer numbers!

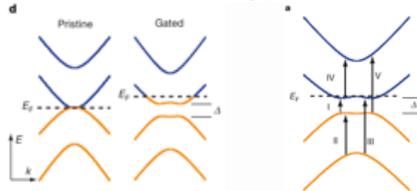
**But the first thing in any experiment is
to identify the exact thickness.**

Properties sensitive to thickness

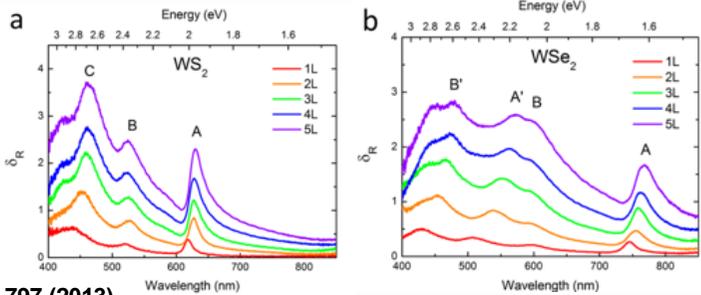


Phy. Rev. B 80, 235402 (2009).

Nature 459, 820-823 (2009).

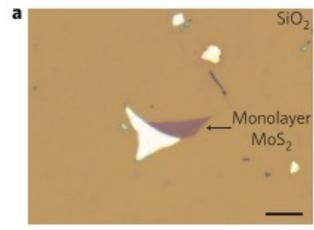


Monolayer-Bilayer-Trilayer Graphene

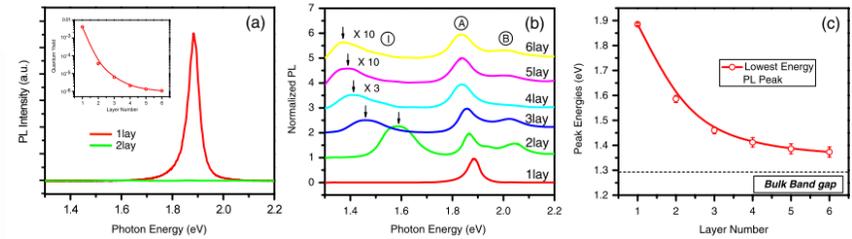


ACS Nano 7, 791-797 (2013).

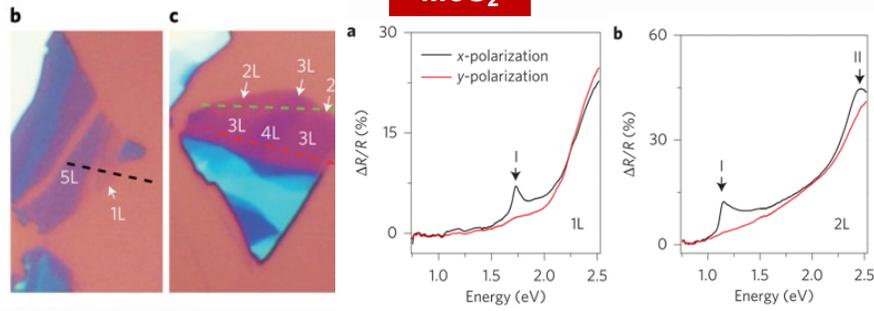
WS₂; WSe₂



Nat. Nanotech. 6, 147-150 (2010).
Phy. Rev. Lett. 105, 136805 (2010).



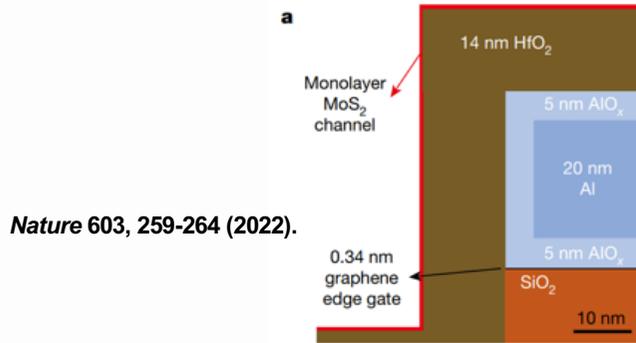
MoS₂



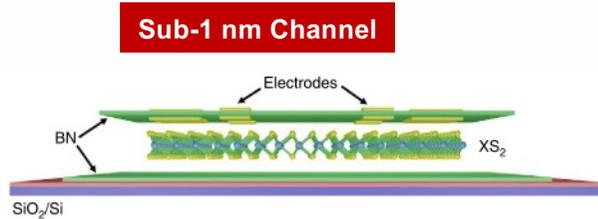
Black phosphorus

Nat. Nanotechnol. 12, 21-25 (2017)

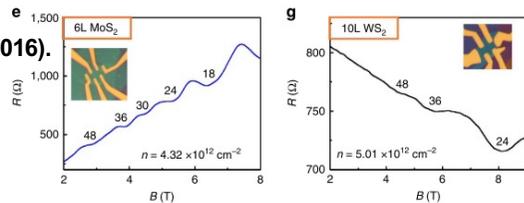
Properties sensitive to thickness



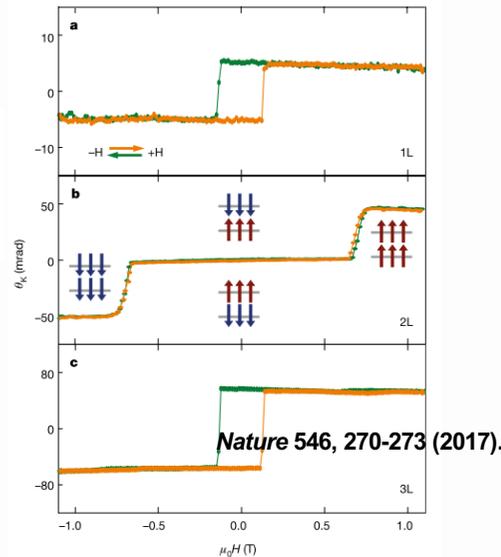
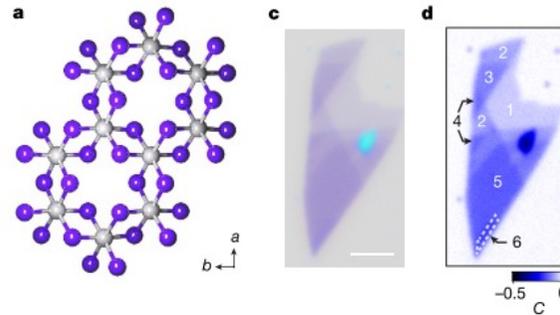
Nature 603, 259-264 (2022).



Nat. Commun. 7, 12955 (2016).

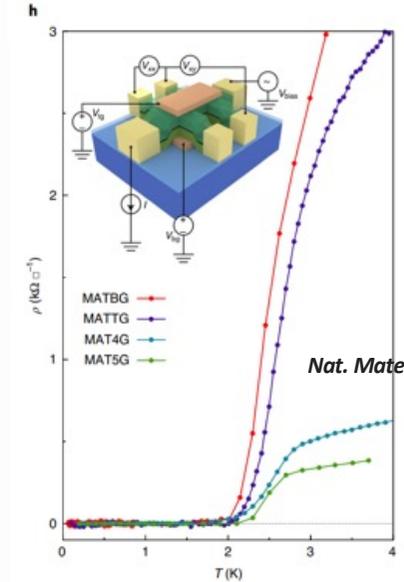
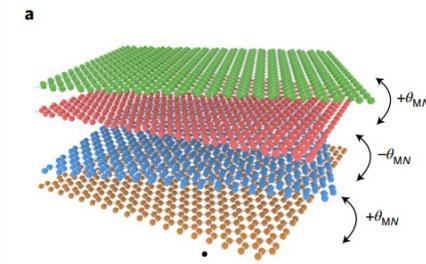


Q-valley electron



Ferromagnetism

GreEnergy



Magic-angle twisted Graphene

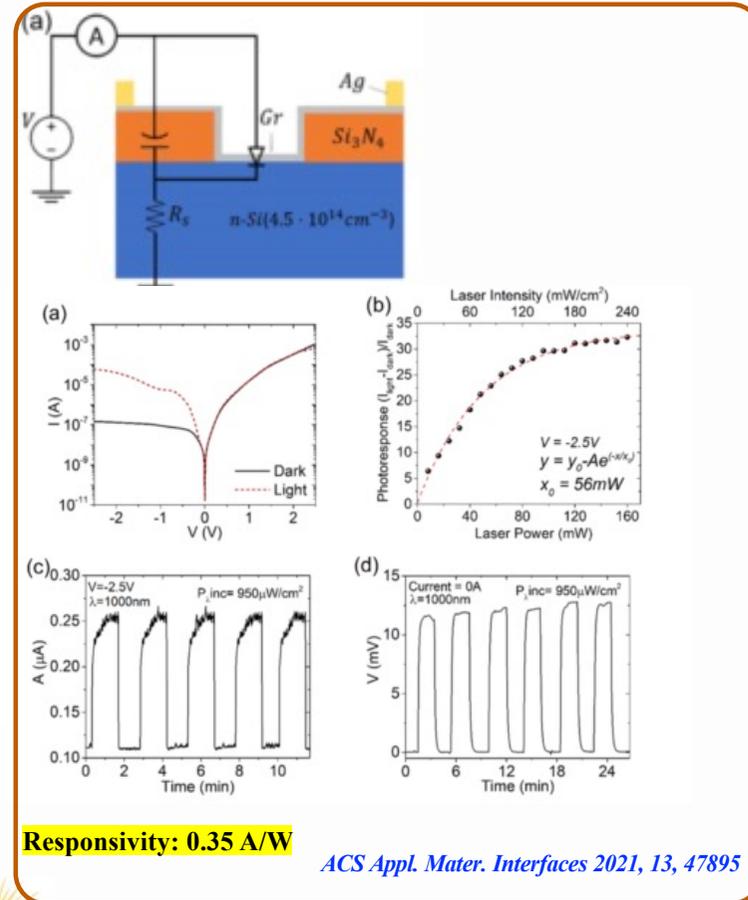
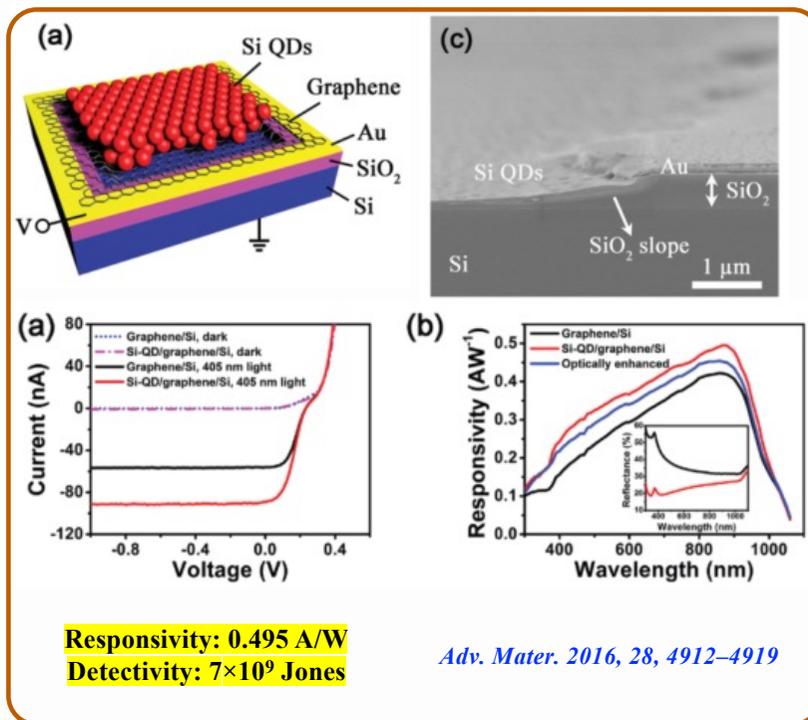
Graphene: Problem 2

Zero bandgap semimetal

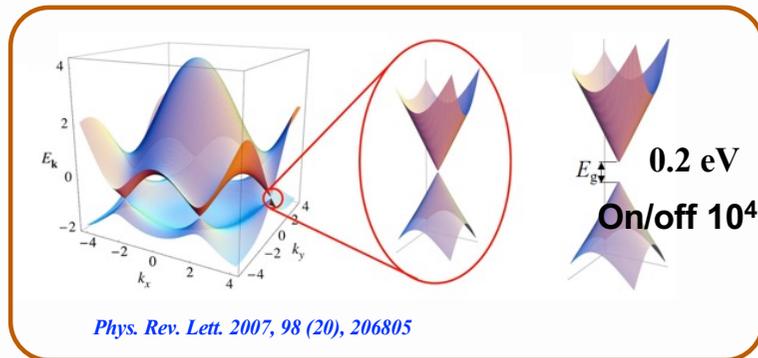
It is not a semiconductor!

**So, it is not of much use for electronics
as the active layer.**

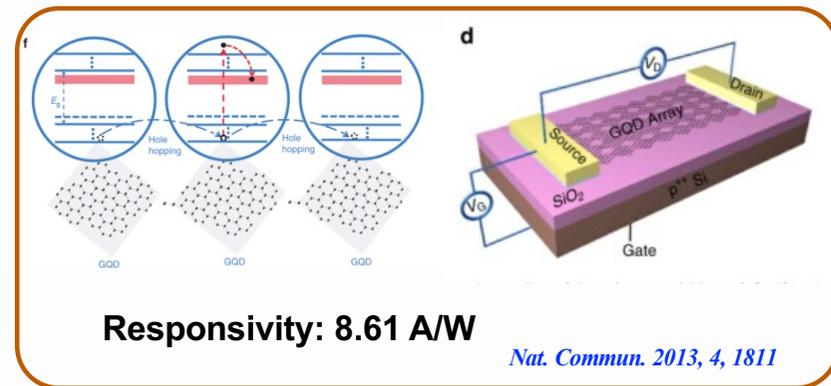
✓ Used as transparent electrode



✓ Try to generate a bandgap



Graphene nanoribbon



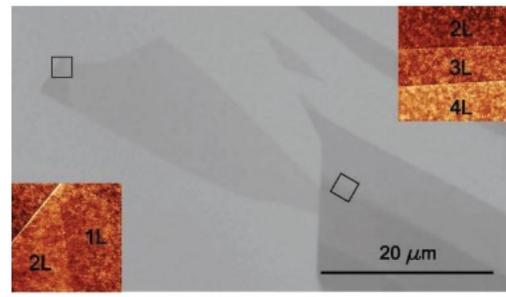
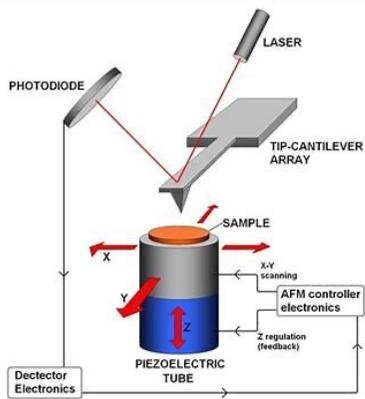
Graphene quantum dots

- Only very small bandgap achieved
- Edge imperfection due to lithography limitation

Planar THz Devices and Graphene Tunnelling Diodes

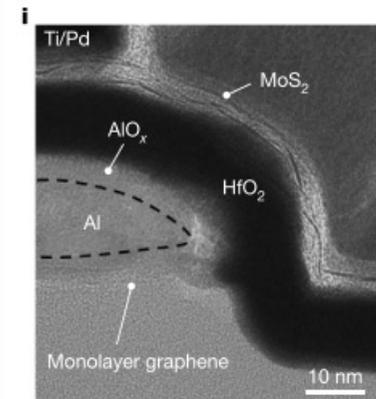
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- ❖ Summary

Methods to identify the number of atomic layers



Small 7, 465–468 (2011).

Atomic force microscope (AFM)

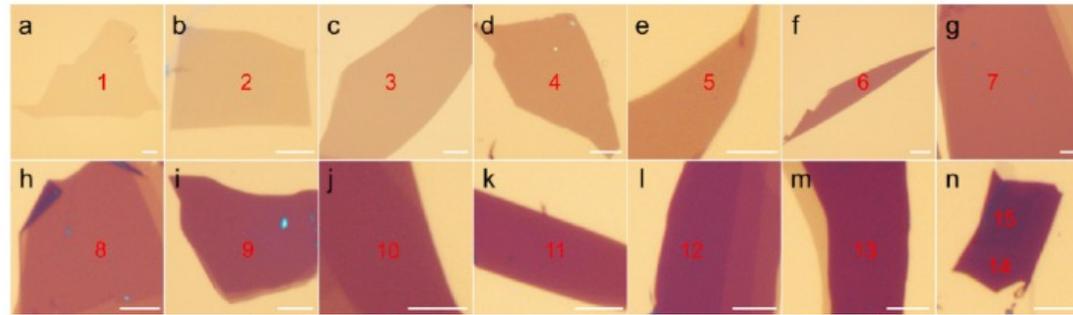


Nature 603, 259-264 (2022)

Tunneling electron microscopy (TEM)

Highly time consuming and expensive

Most commonly used in labs



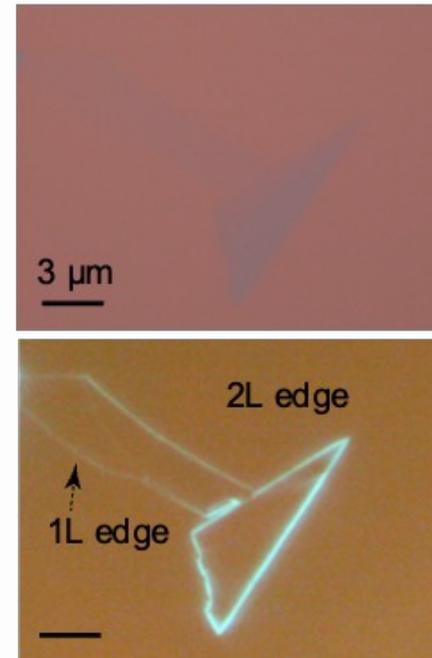
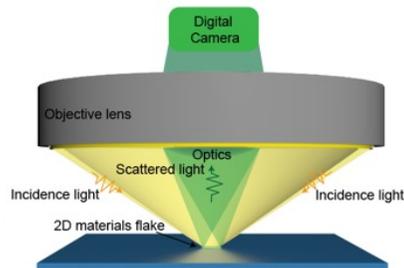
ACS Nano 7, 10344-10353 (2013).

- **Very low contrast**
- Sensitive to wavelength, **substrate thickness, incapable on transparent substrate....**
- Contrast usually **< 10 %** for single-layered graphene
 < 2% for single-layer h-BN (transparent)
- Very rare to see single-layered h-BN based devices

Dark-field method for BN flakes



Standard microscope with dark field



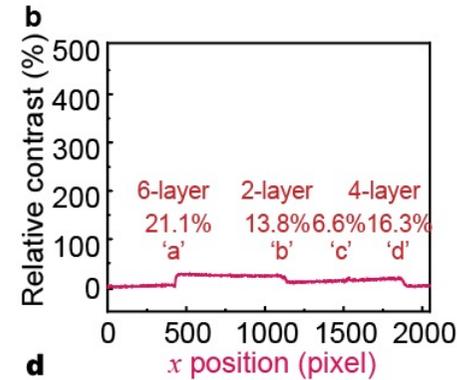
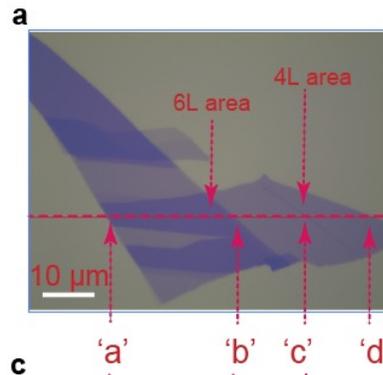
**H-BN
exfoliated
on Si/SiO₂**

- High contrast at the edge of atomically thin h-BN flake
- Single layered BN is now very visible

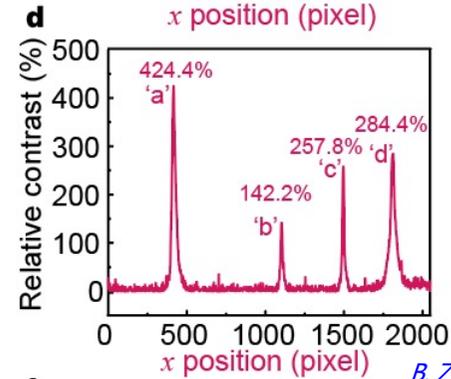
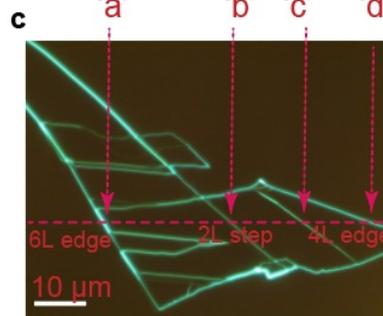
B. Zhang, et al., Nano Letters 23, 9170 (2023)

Dark-field method for graphene flakes

Optical reflection method
White light



Dark-field method
White light

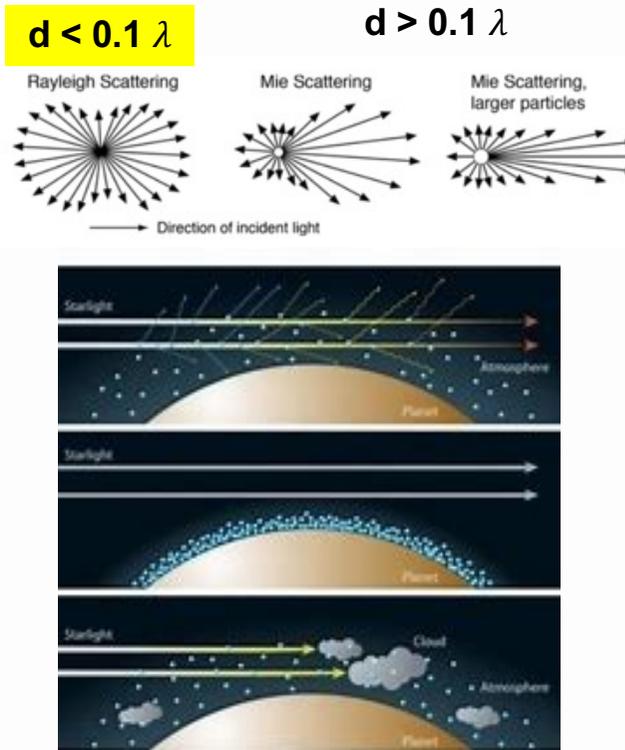


B. Zhang, et al., Nano Letters 23, 9170 (2023)

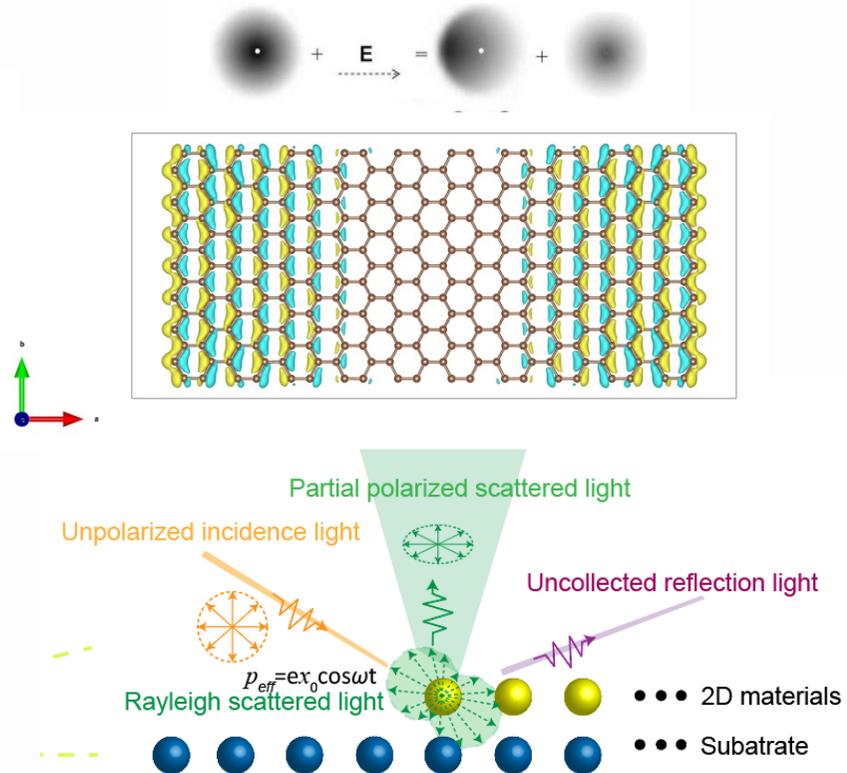
Per-layer contrast increased from 5% to 70%

Rayleigh scattering and charge-dipole model

Rayleigh scattering



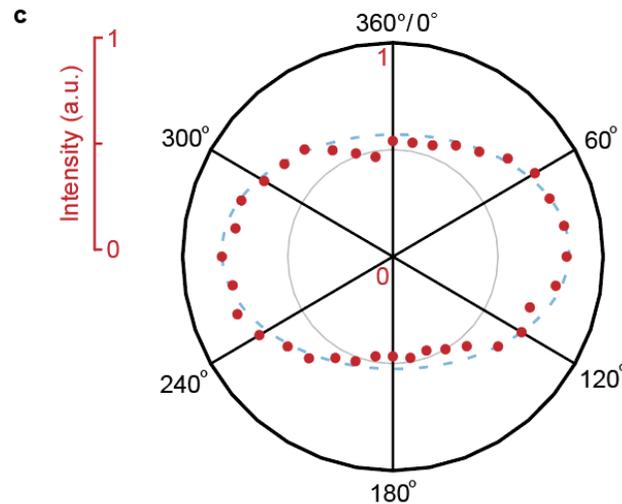
Charge-dipole model



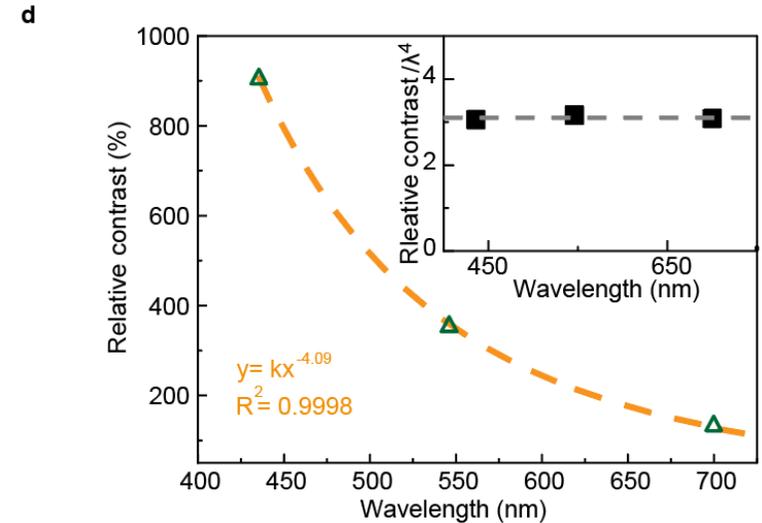
Polarization distribution and wavelength dependence of Rayleigh scattering

$$\bar{S} = \frac{c\pi^2 |\mathbf{p}_{eff}|^2}{2\epsilon_0 r^2 \lambda^4} (1 + \cos^2 \theta)$$

Our model



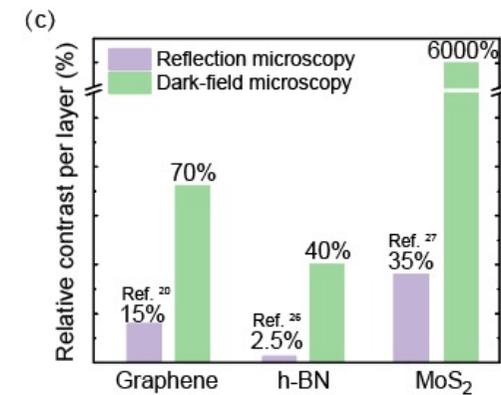
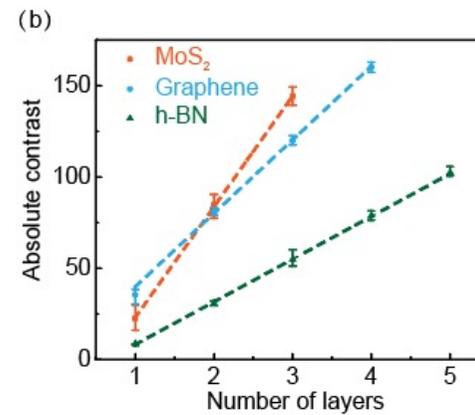
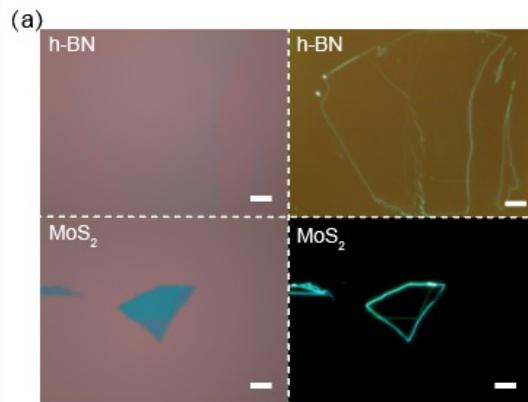
Fitting the partial polarization distribution



Fitting the λ^{-4} relationship

Good agreement between our model and experiment

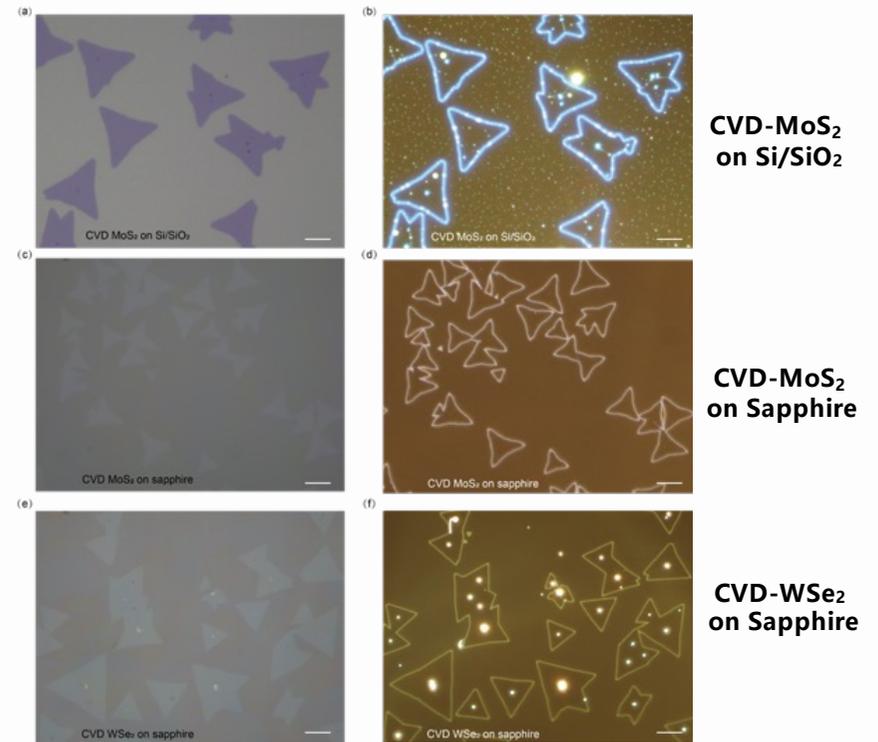
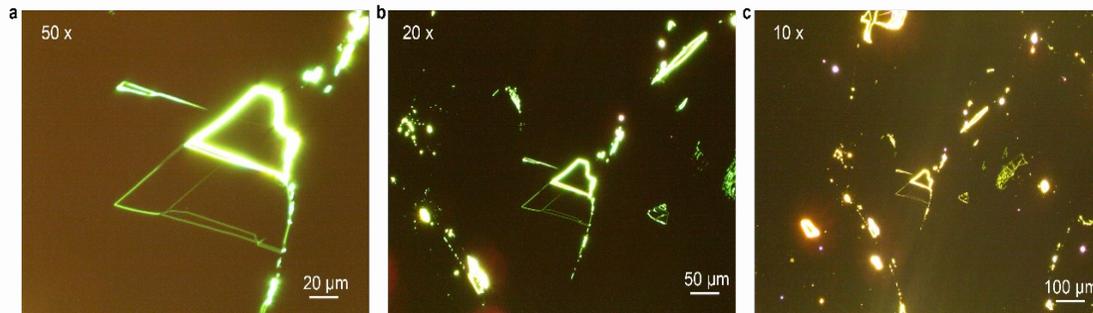
B. Zhang, et al, Nano Letters 23, 9170 (2023)



- Highly linear dependence of the contrast on the number of layers

B. Zhang, et al., Nano Letters 23, 9170 (2023)

Large-area identification, transparent substrate



Large field of vision achieved, up to 0.8 x 1.2 mm²

Feasible on transparent substrates!

B. Zhang, et al., Nano Letters 23, 9170 (2023)

Comparison with optical reflection method

	Materials	Method	Per layer contrast	Detection range	Optimized wavelenth of the incident light	Optimized thickness of the SiO ₂ layer	Reference
1	graphene	ORC	15%	2 - 4 L	550 - 600 nm	285 nm	Ref.S1
2	Graphene;MoS ₂	Deep learning;ORC	N.A.	2 -5 L	White light	300 nm	Ref.S2
3	graphene	ORC	6%	1 - 10 L	550 nm	285 nm	Ref.S3
4	graphene	ORC	7.70%	2 - 5 L	550 nm	300 nm	Ref.S4
5	h-BN	ORC	2.50%	1 - 100 L	516 nm	282 nm	Ref.S5
6	h-BN	Raman;ORC	1.50%	7 -38 L	525 nm	290 nm	Ref.S6
7	h-BN	Raman;ORC	2.50%	2 - 4 L	500 or 570 nm	290 nm	Ref.S7
8	MoS ₂	Deep learning;ORC	N.A.	1 - 5 L	470 - 850 nm	270 nm	Ref.S8
9	MoS ₂	ORC	9%	1 - 15 L	White light, with RGB channel	300 nm	Ref.S9
	WSe ₂	ORC	14%	1 - 14 L	White light, with RGB channel	300 nm	
	MoS ₂	ORC	35%	1 - 15 L	White light, with RGB channel	90 nm	
	WSe ₂	ORC	38%	1 - 14 L	White light, with RGB channel	90 nm	
10	Graphene	Dark-field	70%	1 ->100 L	White light, better at shorter wavelength	Not required	This work
	h-BN	Dark-field	40%	1 ->100 L			
	MoS ₂	Dark-field	6000%	1 ->100 L			

- Contrast for graphene increased by a factor ~ 10
- Contrast for BN increased by a factor ~ 20
- Contrast for MoS₂ increased by a factor ~ 200

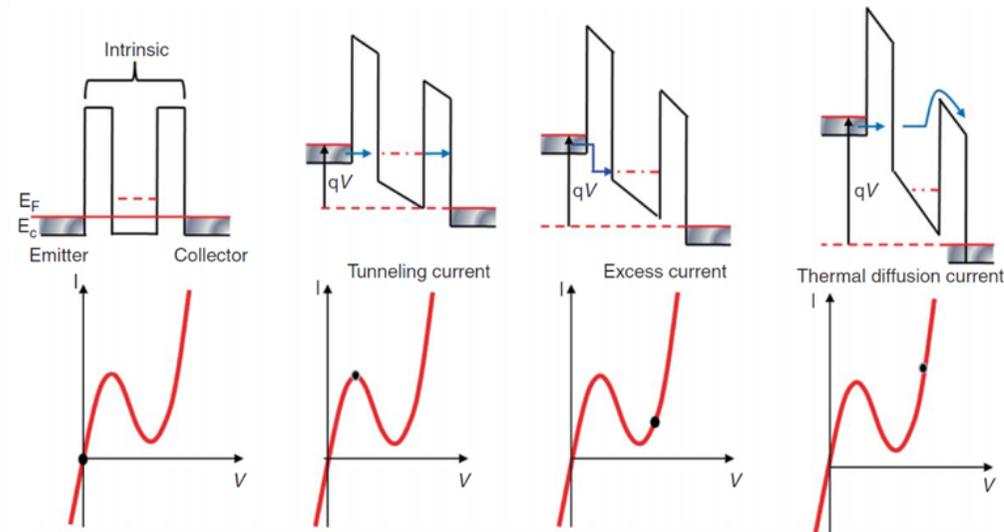
B. Zhang, et al, Nano Letters 23, 9170 (2023)

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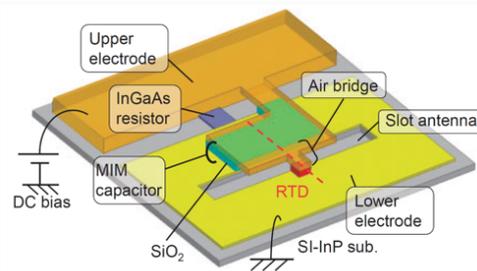
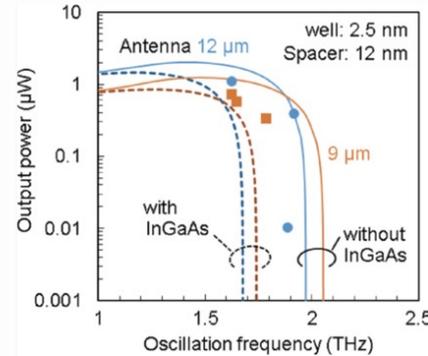
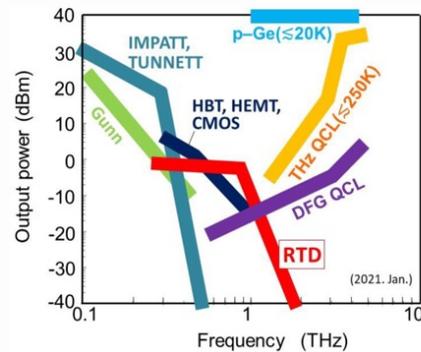
Resonant tunnelling diode

- Predicted by Tsu and Esaki in 1973
- Demonstrated by Chang, Esaki and Tsu in 1974
- Room-temperature quantum device
- Negative differential resistance
- Applications: high-frequency oscillators (>1 THz), multi-value logic, memory, etc



Tsu R, Esaki L. APL, 1973, 22: 562
Chang L L, Esaki L, Tsu R. APL, 1974, 24: 593

Resonant tunnelling diode for THz



Upper electrode		
n ⁺ -InGaAs (Graded)	9 nm ($\sim 5 \times 10^{19} \text{cm}^{-3}$)	
n ⁺ -In _{0.53} Ga _{0.47} As	15 nm ($\sim 5 \times 10^{19} \text{cm}^{-3}$)	
un-In _{0.53} Ga _{0.47} As	Collector spacer: 12 nm	
AlAs	Barrier: 1 nm	
un-In _{0.53} Ga _{0.47} As	Well: 2.5 nm	RTD
AlAs	Barrier: 1 nm	
un-In _{0.53} Al _{0.18} Ga _{0.29} As	Spacer: 2 nm	Step emitter
n-In _{0.53} Al _{0.18} Ga _{0.29} As	20 nm ($3 \times 10^{18} \text{cm}^{-3}$)	
n ⁺ -In _{0.53} AlGaAs	15 nm ($\sim 5 \times 10^{19} \text{cm}^{-3}$)	
n ⁺ -In _{0.53} Ga _{0.47} As	400 nm ($\sim 5 \times 10^{19} \text{cm}^{-3}$)	
Lower electrode		
SI-InP Sub.		

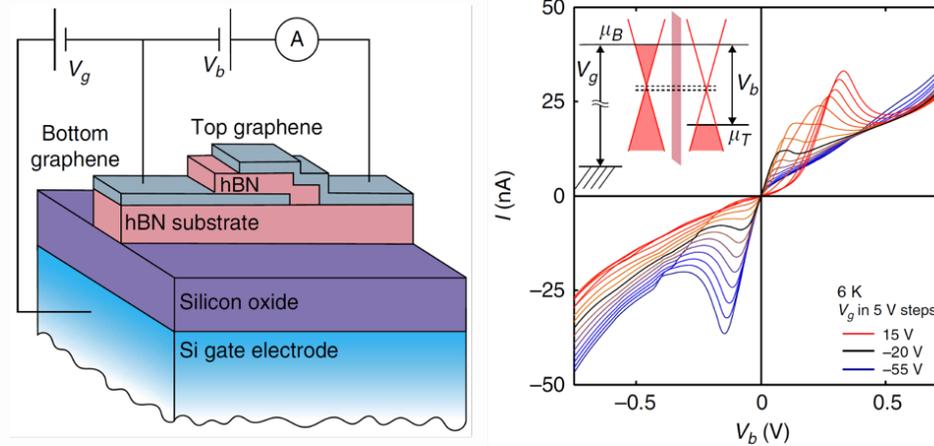
Maekawa T, Kanaya H, Suzuki S, Asada M. *Applied Physics Express*, 2016, 9(2): 024101.

Izumi R, Suzuki S, Asada M. 2017 42nd International Conference on Infrared, Millimeter, and Terahertz Waves (IRMMW-THz). 2017.

Asada M, Suzuki S. *Sensors (Switzerland)*, 2021, 21(4): 1384.

- Oscillators up to 1.98 THz
- Currently used as solid-state THz emitter at 300K

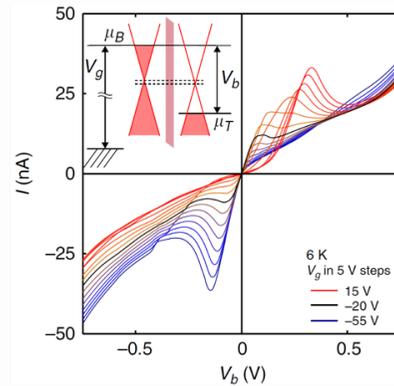
Graphene resonant tunnelling diode



Britnell L et al. Nature Communications, 2013, 4: 1794.

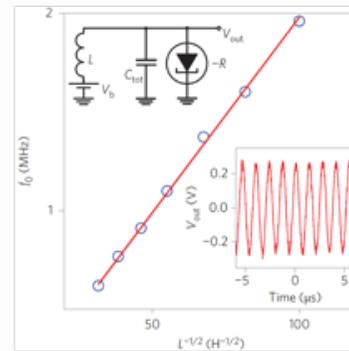
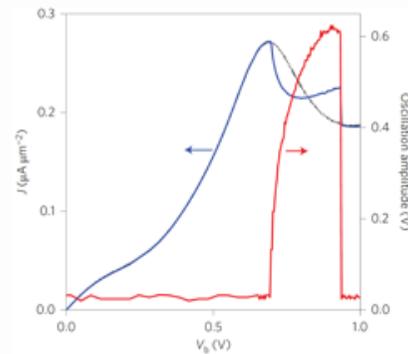
- Atomically flat 2D materials extremely suitable for tunnelling diodes
- 2D-to-2D tunnelling is much **more ideal** than conventional 3D-2D-3D tunnelling
- **Single-barrier** graphene/BN/graphene diode demonstrated in 2013
- Potentially even **higher speed** without the so-called dwell time limitation
- **Difficulty:** identify the atomic-layer numbers of very thin 2D materials

State of the art



Highest peak-to-valley current ratio: 3.9

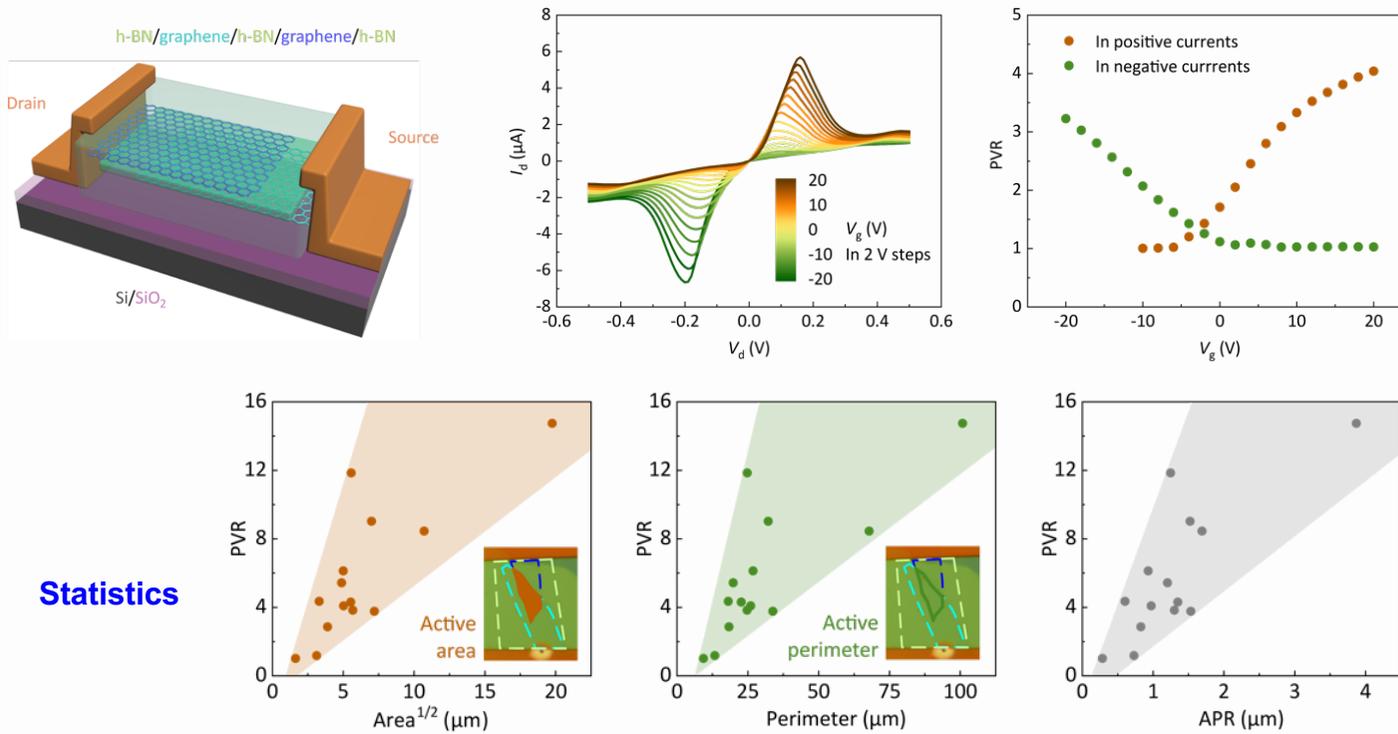
Highest peak current density: 2 $\mu\text{A}/\mu\text{m}^2$



**Highest oscillation
frequency: 2 MHz**

Berger P R, Ramesh A. Amsterdam: Elsevier, *Comprehensive Semiconductor Science and Technology*, 2011, 5:176-241.
 Burg G W, Prasad N, Fallahzad B, et al. *Nano Letters*, 2017, 17(6): 3919–3925.
 Kinoshita K, Moriya R, Okazaki S, et al. *Nano Letters*, 2022, 22(12): 4640–4645.
 Srivastava P K, Hassan Y, de Sousa D J P, et al. *Nature Electronics*, 2021, 4(4): 269–276.
 Al-Khalidi A et al. *IEEE Transactions on Terahertz Science and Technology*, 2020, 10(2): 150-157.

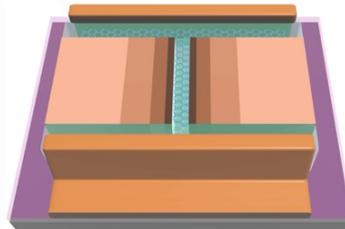
Unexpected size/geometry dependence



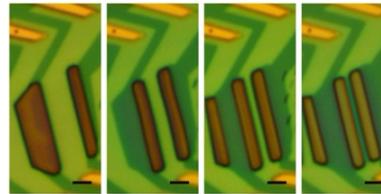
Zihao Zhang et al. *Nano Letters*, 23, 8132 (2023)

- Helped by the dark field method to identify thin 2D material thickness
- Peak to valley ratio (PVR) depends on area, perimeter and area/perimeter

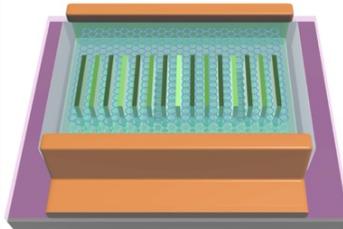
Controlled tests on the same device



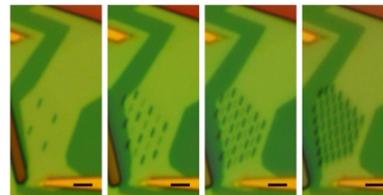
- Etching #1
- Etching #2
- Etching #3
- Etching #4



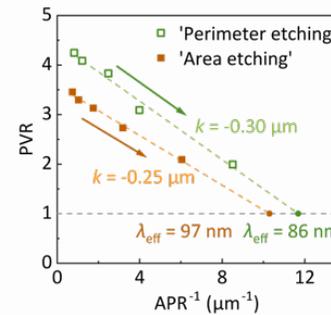
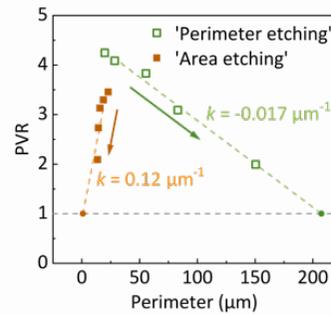
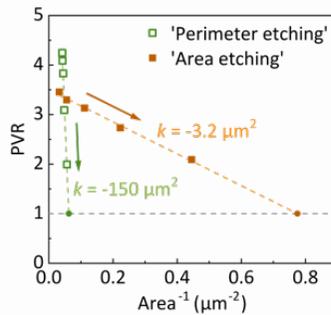
**Different areas but
perimeter almost the same**



- Etching #1
- Etching #2
- Etching #3
- Etching #4

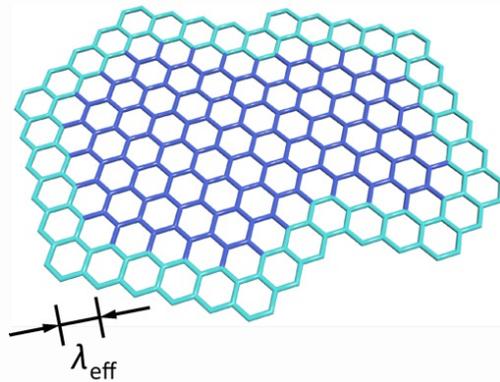


**Different perimeters but
area almost the same**



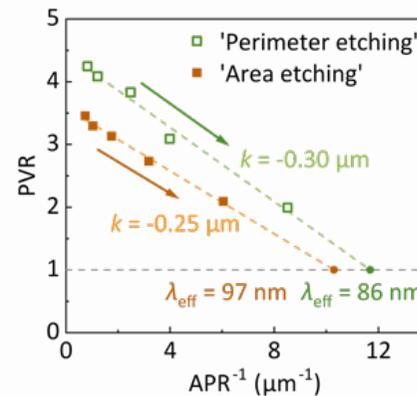
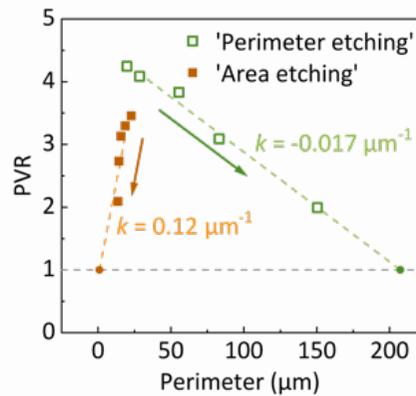
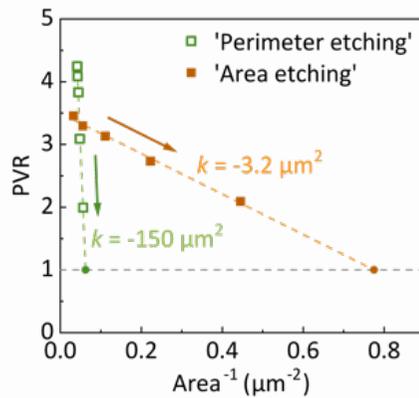
Area/perimeter is the key!

Edge doping model



$$PVR \approx \frac{J_l(V_{d,peak}) \times (\text{Area} - \text{Perimeter} \times \lambda_{eff}) + J_h(V_{d,peak}) \times \text{Perimeter} \times \lambda_{eff}}{J_l(V_{d,valley}) \times (\text{Area} - \text{Perimeter} \times \lambda_{eff}) + J_h(V_{d,valley}) \times \text{Perimeter} \times \lambda_{eff}}$$

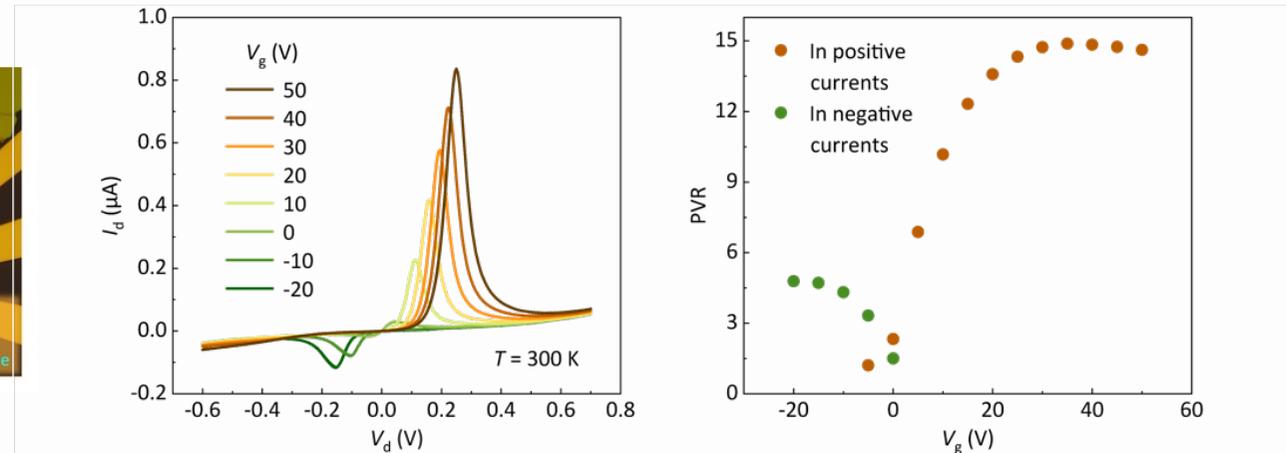
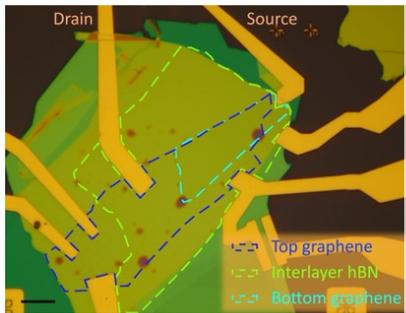
$$PVR \approx \frac{J_l(V_{d,peak})}{J_l(V_{d,valley})} - \left(\frac{J_l(V_{d,peak})}{J_l(V_{d,valley})} - 1 \right) \frac{\lambda_{eff}}{APR}$$



Fitting:
 $\lambda_{eff} = 97 \text{ nm}$

Zihao Zhang et al. Nano Letters, 23, 8132 (2023)

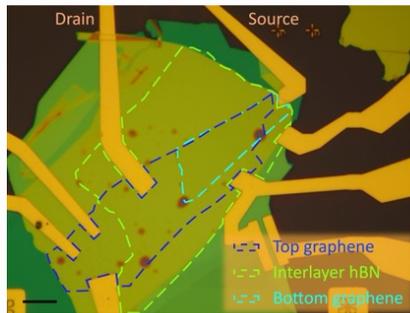
Optimized resonant tunnelling diode



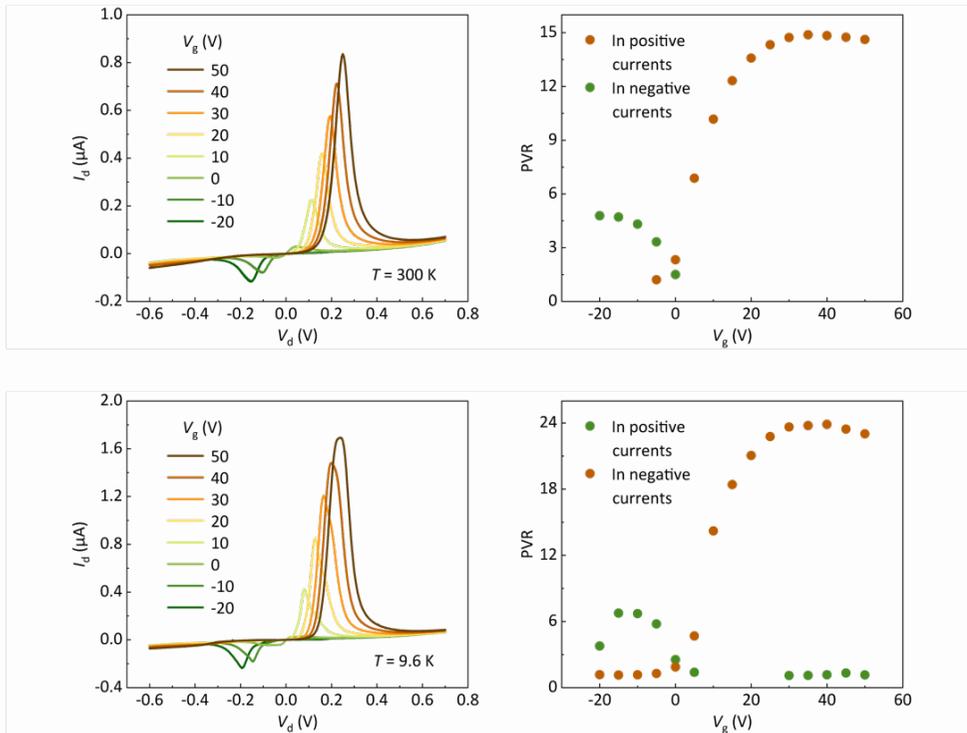
- Room temperature PVR = **14.9**
- A factor of **380% increase** from the previous record

Zihao Zhang et al. *Nano Letters*, 23, 8132 (2023)

Optimized resonant tunnelling diode

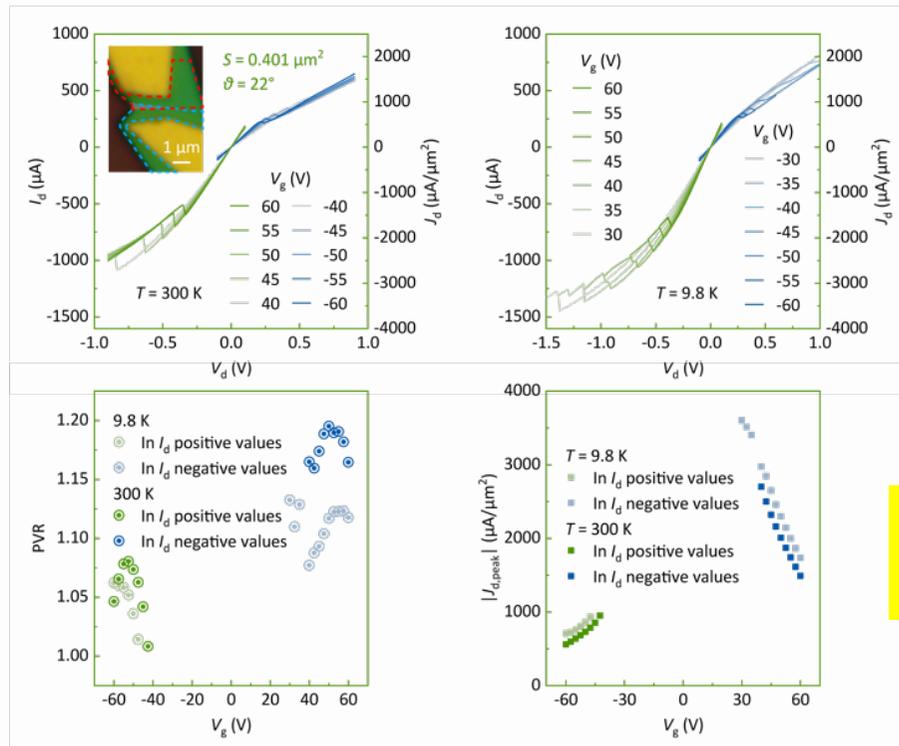


• PVR=23.9 @ 9.6 K



Zihao Zhang et al. *Nano Letters*, 23, 8132 (2023)

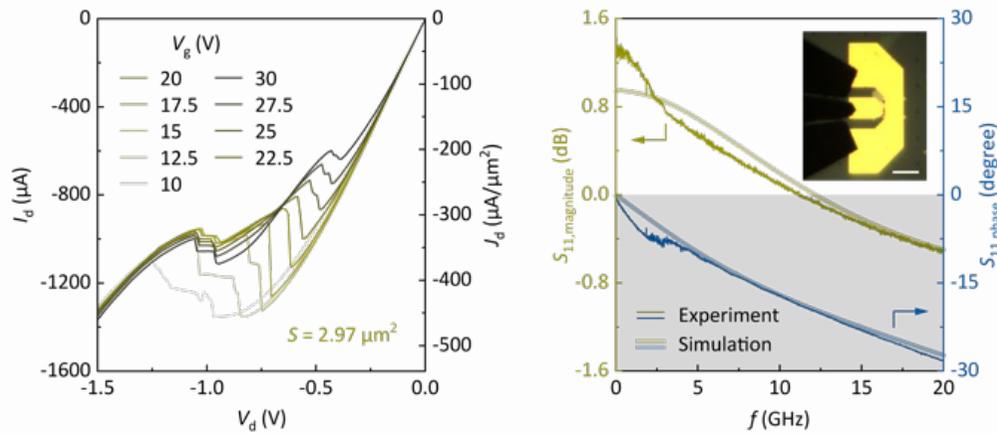
Optimized resonant tunnelling diode



- Peak current density: $2700\ \mu\text{A}/\mu\text{m}^2$
- Improved by 3 orders of magnitude

Zihao Zhang et al. To be published

Optimized resonant tunnelling diode



- **Oscillation frequency: 11 GHz**
- **Previous highest: 2 MHz**
- **Increased by 3 orders of magnitude**

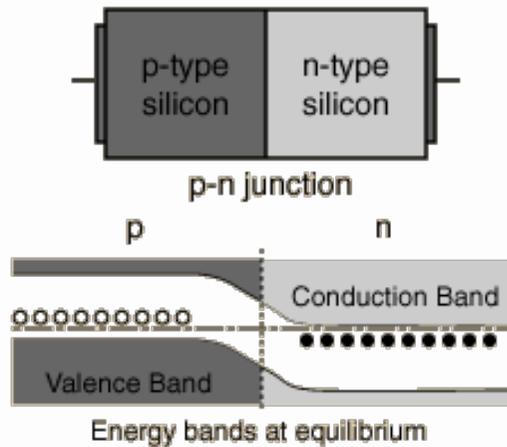
Zihao Zhang et al. To be published

Planar THz Devices and Graphene Tunnelling Diodes

- ❖ Background
- ❖ How to determine 2D material thickness
- ❖ Graphene tunnelling transistors
- ➔ ❖ Planar THz nanodevices
- ❖ Semiconducting graphene nanoribbons
- ❖ Summary

Diode that layman can understand

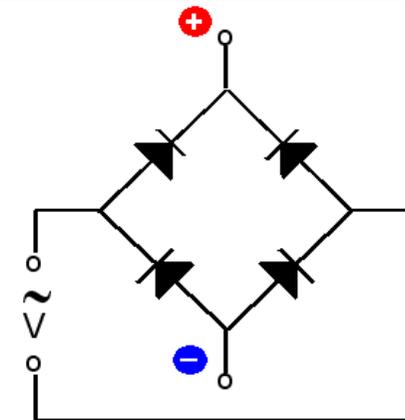
Conventional diode



Only experts understand!

Ballistic Rectifier

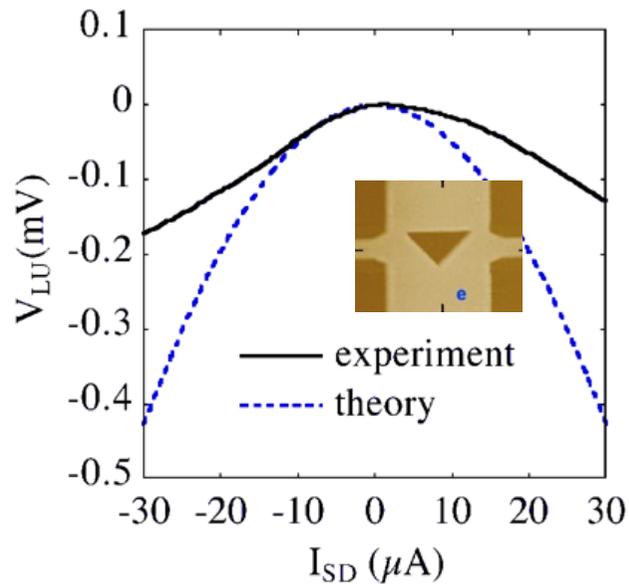
Working principle in the semi-classical regime.



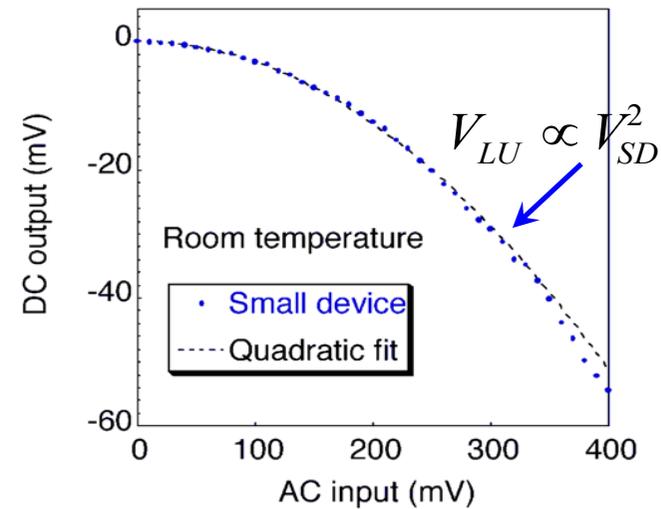
Functions like a **Bridge Rectifier!**

1st diode that layman can understand!

1st diode having intrinsic zero threshold!



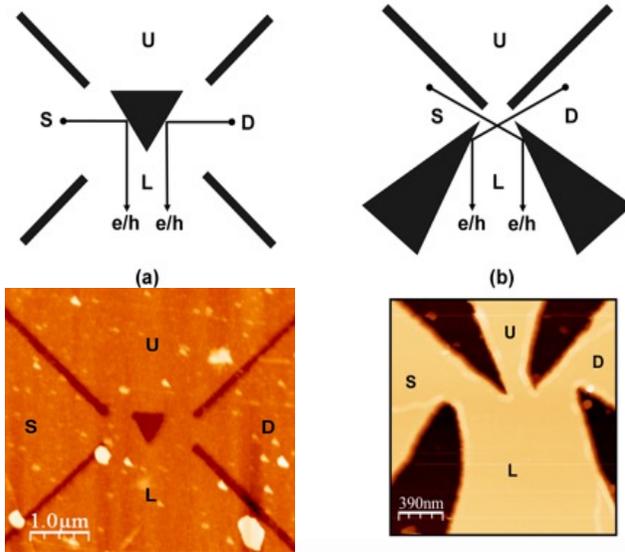
Phys. Rev. Lett. 80, 3831; Phys. Rev. B59, 9806



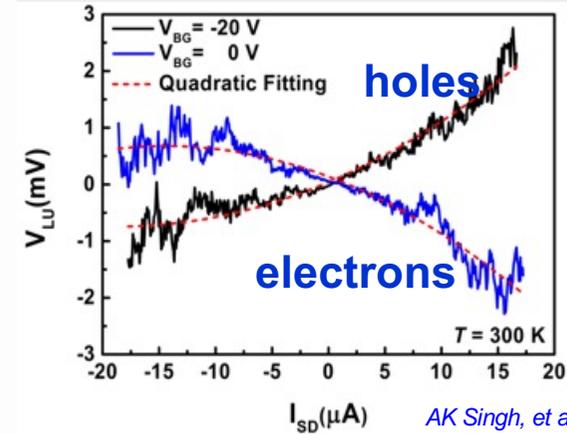
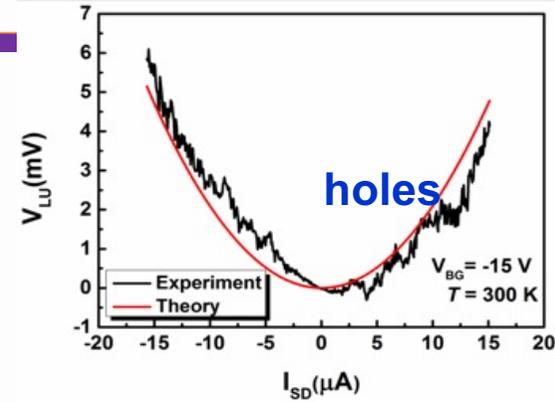
Japn. J. Appl. Phys. 40, L909; Appl. Phys. Lett. 79, 1357

- ✓ New device concept and working principle
- ✓ Zero threshold, no need of DC biasing
- ✓ Parabolic (not exponential), quadratic response

Graphene Ballistic Rectifier



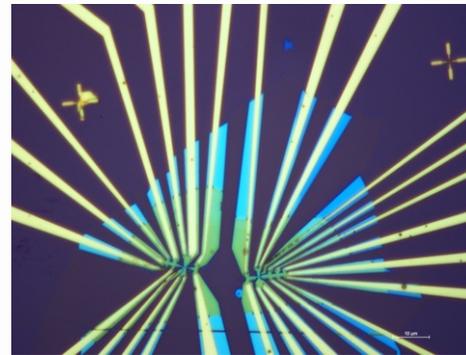
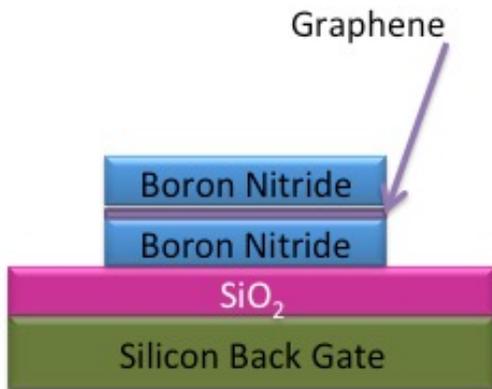
- Graphene flake directly placed on SiO₂
- **Low mobility: ~2000 cm²/Vs**
- Device size > mean free path



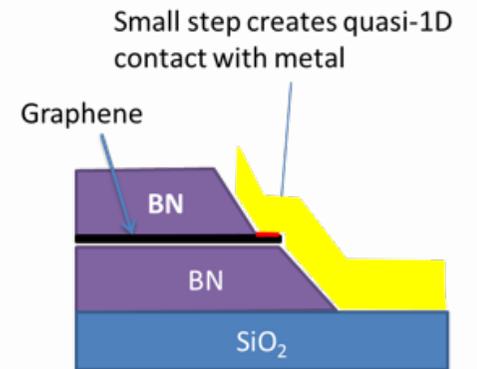
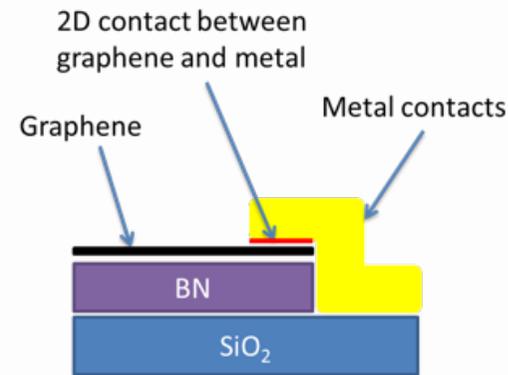
AK Singh, et al, 2D Materials 5 (3), 035023 (2018)
AK Singh, et al, Carbon 84, 124-129 (2015)

- ✓ **Both devices worked at 300K**
- ✓ **Thermoelectric effect ruled out due to opposite output**

High mobility graphene & 1D contact



Hall bars by e-beam lithography

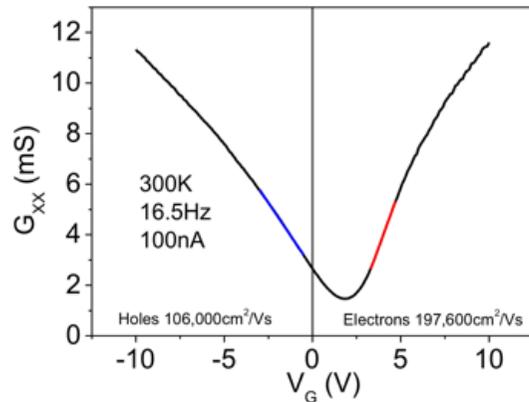
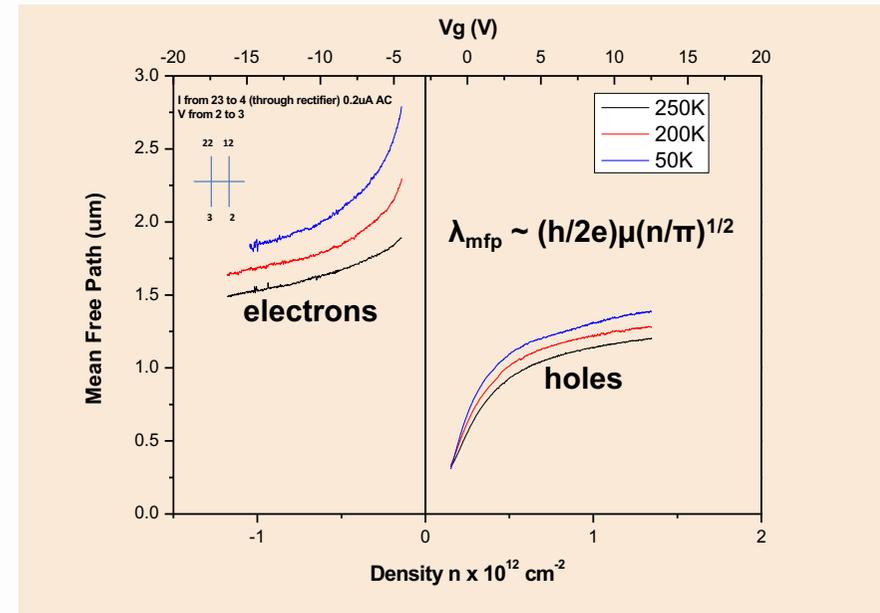
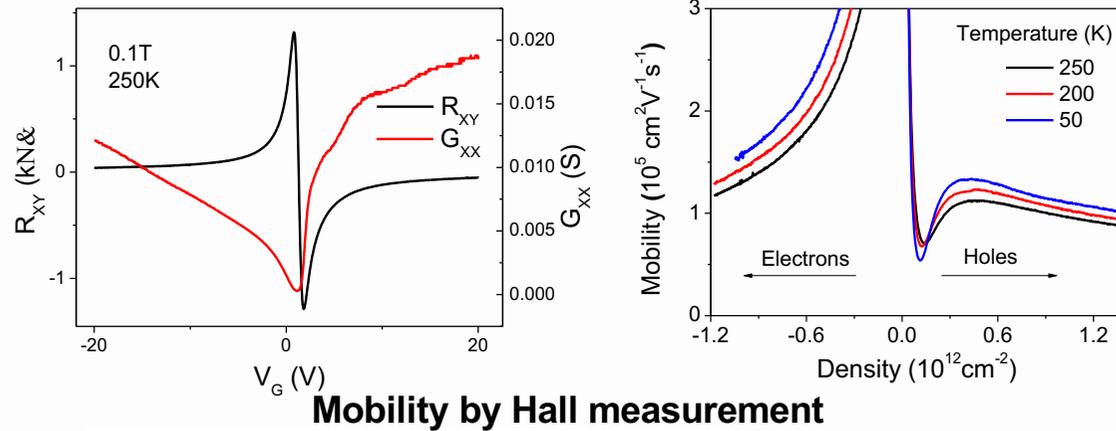


L. Wang, et al. Science 342, 614 (2013).

BN enables ultralow surface states/traps

1D contact to reduce series resistance

High-mobility graphene



Mobility by field-effect measurement

- **Mobility ~ 200,000 cm²/Vs at 300 K**
- **Close to theoretical limit**
- **Mean free path: 1-2 microns**

G. Auton, et al, Nature Communications, 7:11670 (2016)



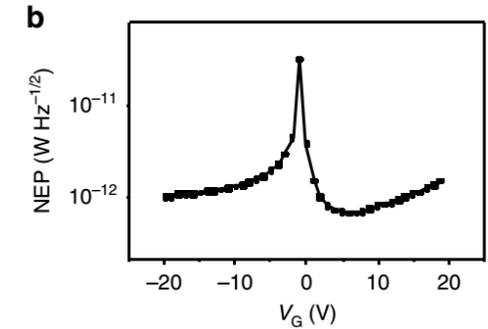
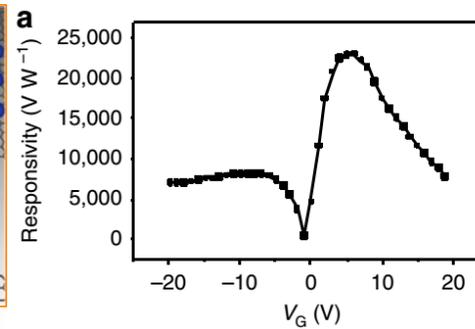
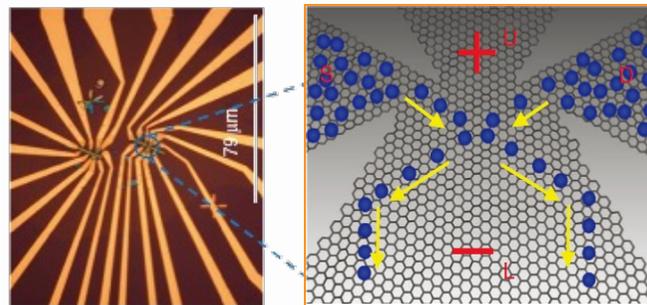
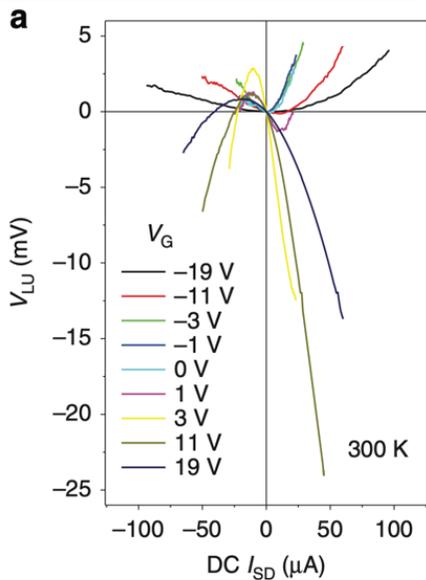
ARTICLE

Received 15 Dec 2015 | Accepted 18 Apr 2016 | Published 31 May 2016

DOI: 10.1038/ncomms11670

OPEN

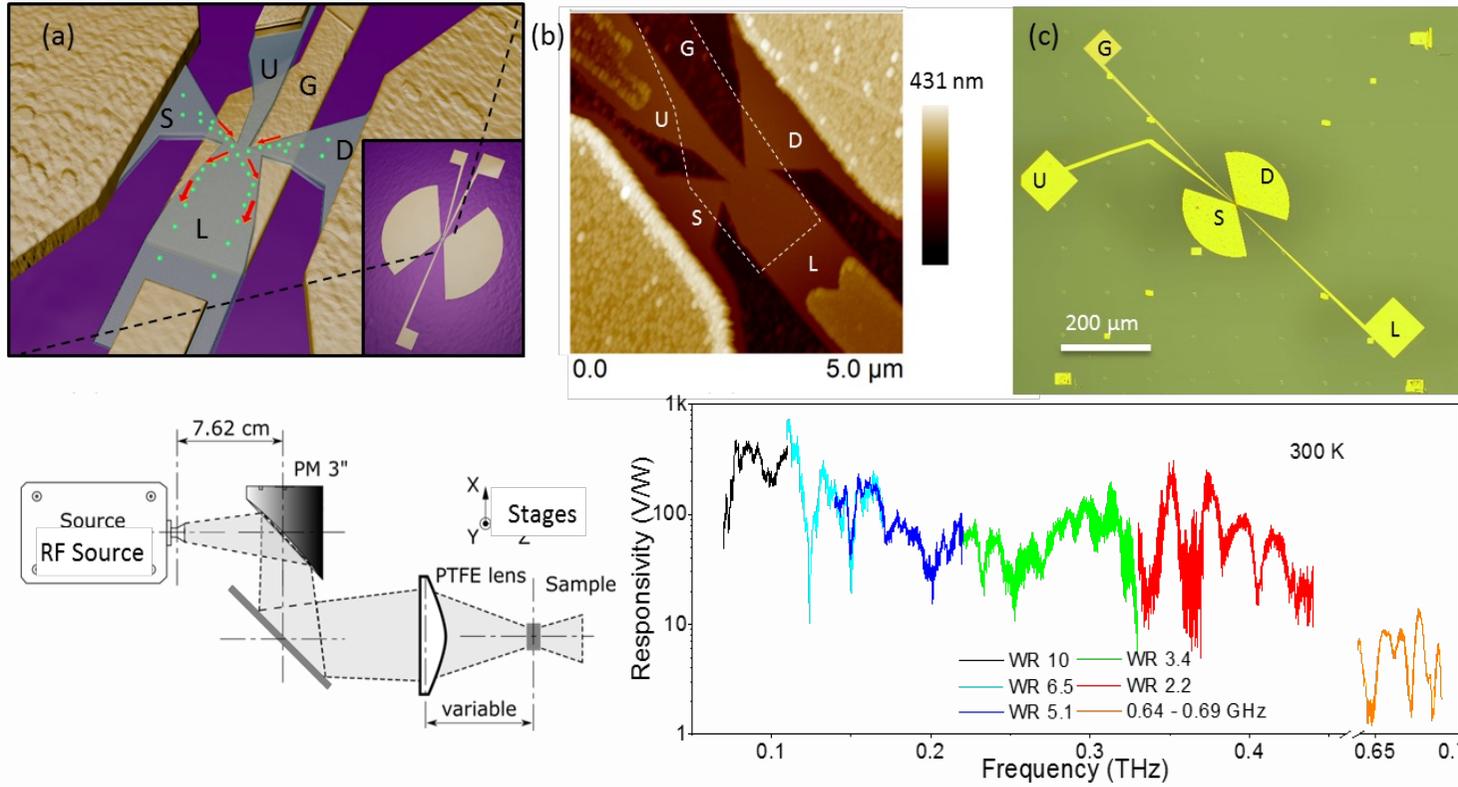
Graphene ballistic nano-rectifier with very high responsivity



- Room temp responsivity: 23,000 V/W
- Record sensitivity (NEP) for microwave detection at 300 K, <1 pW/Hz^{1/2}
- Comparable to superconductor bolometer (-270°C)

G. Auton, et al, Nature Communications, 7:11670 (2016)

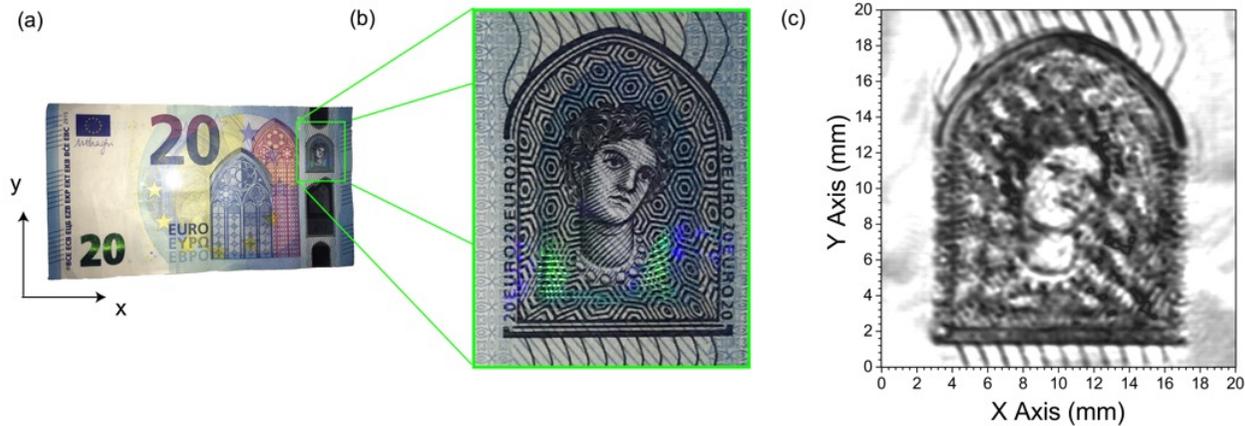
Microwave detection up to 680 GHz



One of the fastest graphene nano-diodes to date

G. Auton, et al., Nano Letters, 17, 7015 (2017)

Imaging at 640 GHz



- First graphene based THz imaging (resolution ~ 1 mm)
- Collaboration with University of Montpellier
- May be exploited as THz camera for airport security / medical imaging

Planar THz Devices and Graphene Tunnelling Diodes

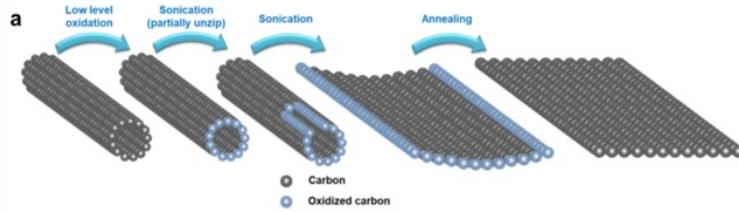
- ❖ Background
- ❖ How to determine 2D material thickness
- ❖ Graphene tunnelling transistors
- ❖ Planar THz nanodevices
- ➔ ❖ Semiconducting graphene nanoribbons
- ❖ Summary

Graphene: Problem 2

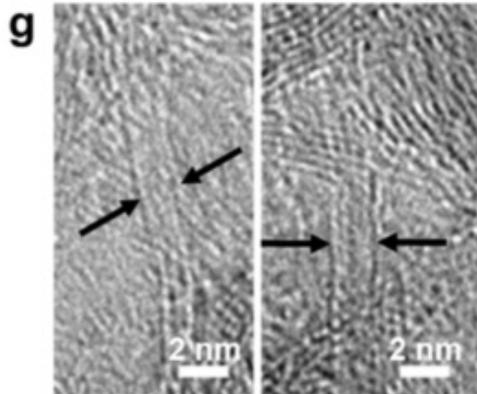
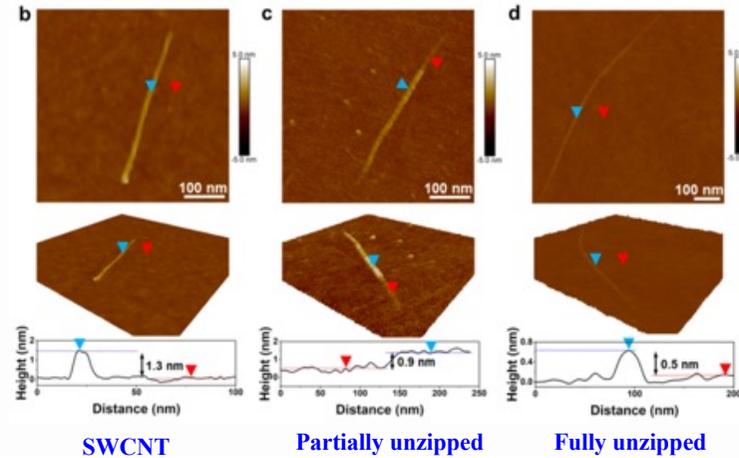
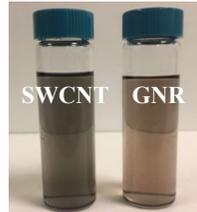
Zero bandgap semimetal
It is not a semiconductor!

**So, it is not of much use for electronics
as the active layer.**

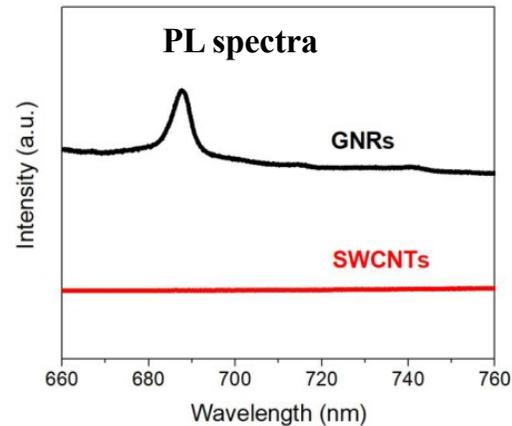
Graphene nanoribbons (GNRs)



- SWCNT + strong acid
- Generate defects
- Unzip by ultrasonic agitation
- Annealing



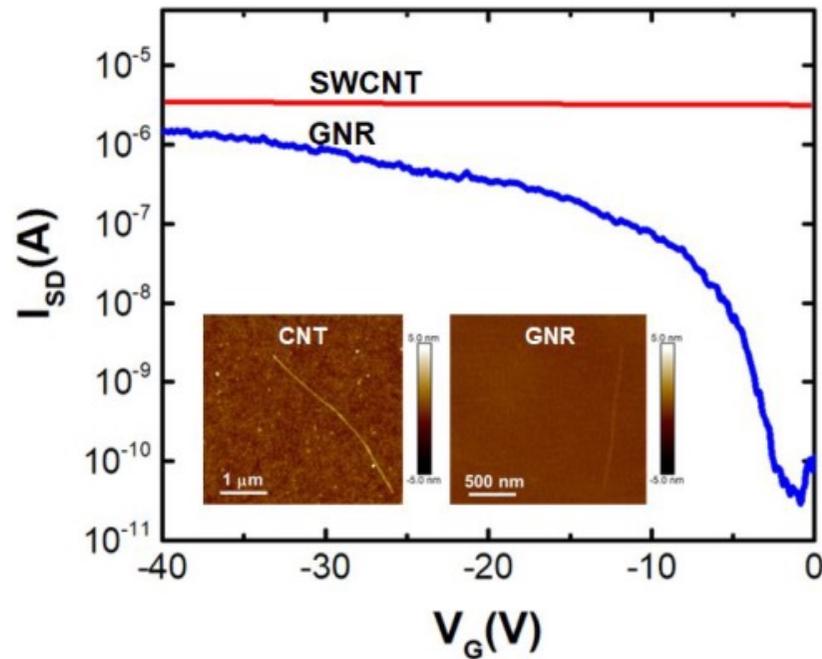
2 nm wide GNR



1.8 eV bandgap

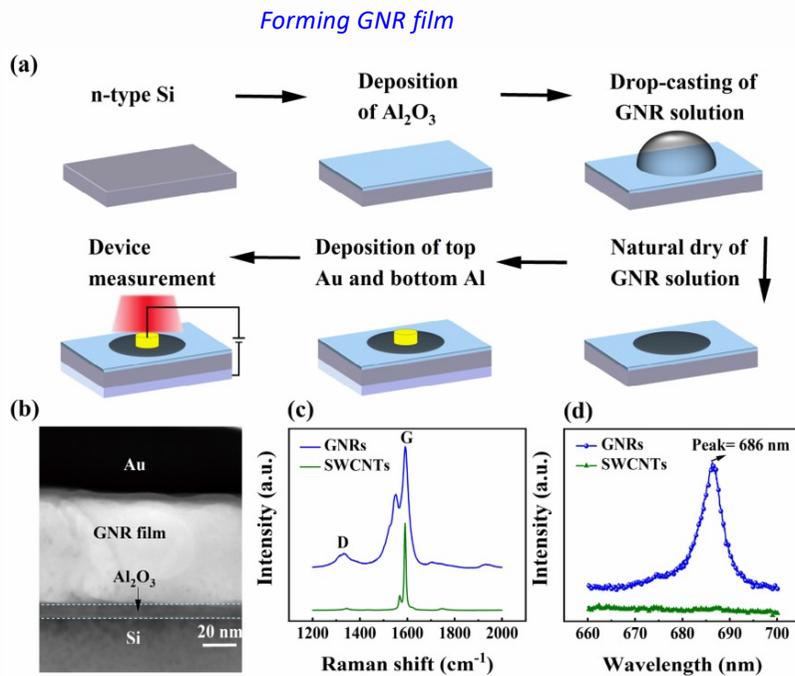
ACS Appl. Mater. Interfaces 13, 52892 (2021)

Graphene nanoribbons TFTs

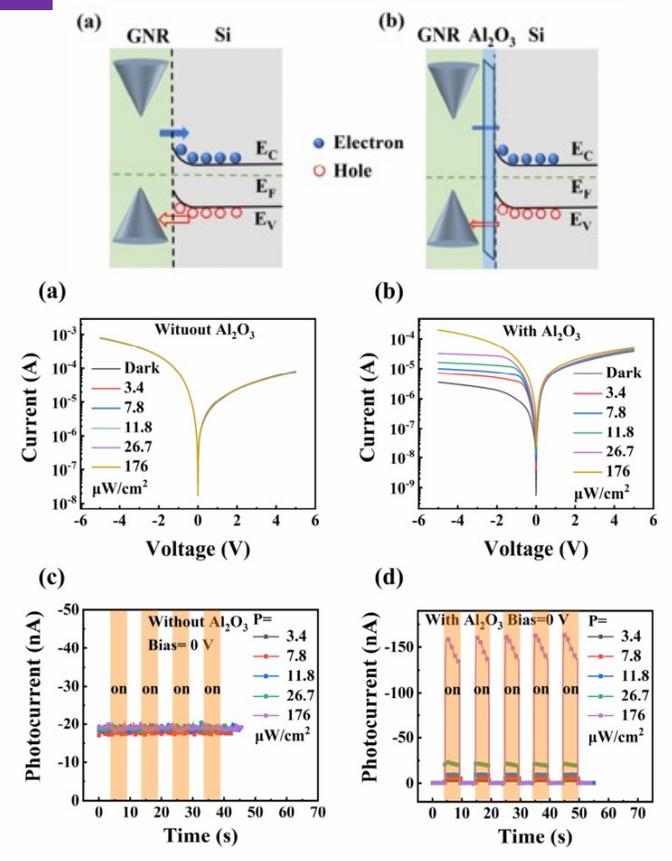


- GNR TFT on/off ratio $>10^5$
- Previous graphene TFT on/off ratio only ~ 10

Graphene nanoribbon photodetectors

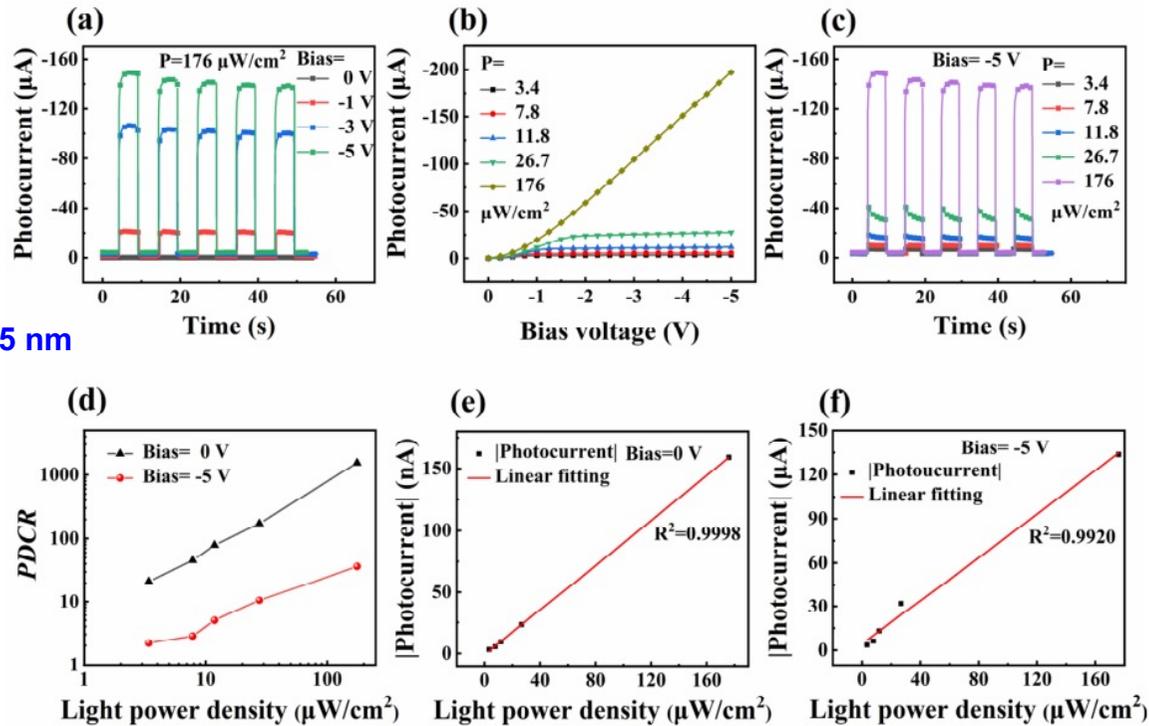


Introducing Al_2O_3 to reduce dark current



M.Y. Wang, *Nano Lett.* 24, 165 (2024)

Graphene nanoribbon photodetectors

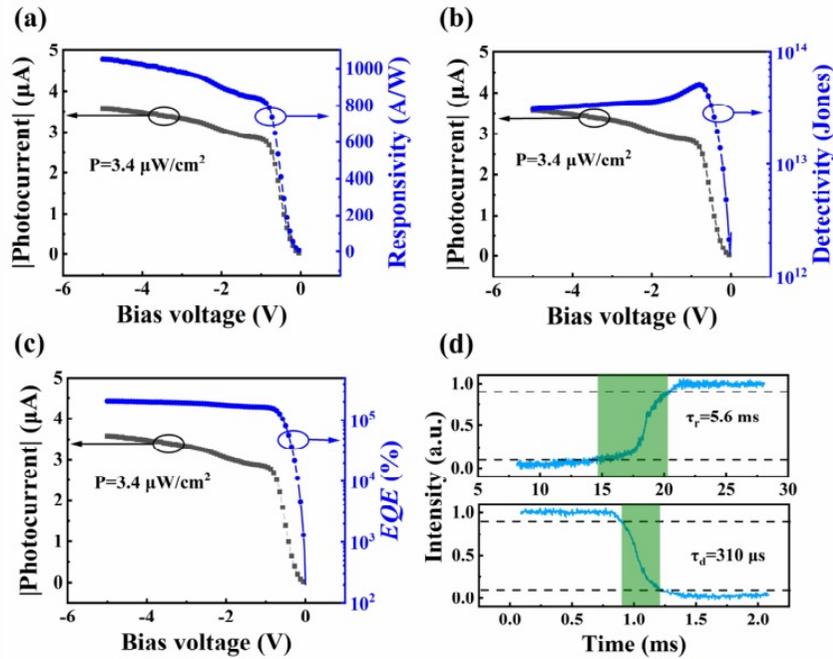


Light wavelength 635 nm

M.Y. Wang, *Nano Lett.* 24, 165 (2024)

Photo-to-dark current ratio (PDCR) at zero bias: 1.5×10^3

Graphene nanoribbon photodetectors

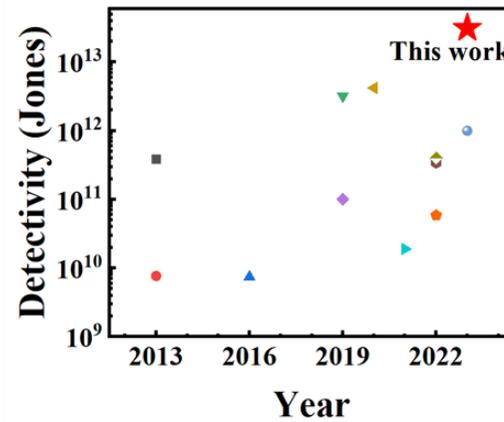
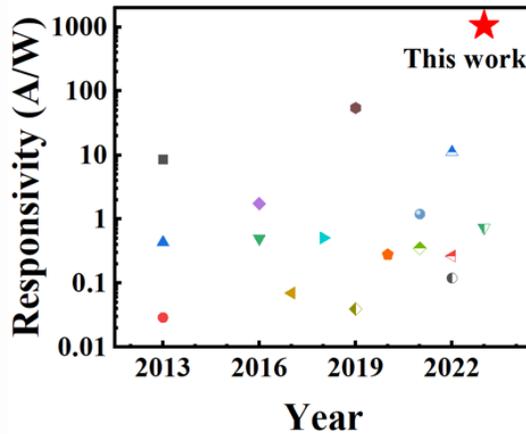


Bias	R (A/W)	D (Jones)	EQE (%)
-5 V	1052	3.13×10^{13}	2×10^5
0 V	1.04	2.45×10^{12}	200

M.Y. Wang, Nano Lett. 24, 165 (2024)

- Responsivity 1,052 A/W
- Response time: 310 μs

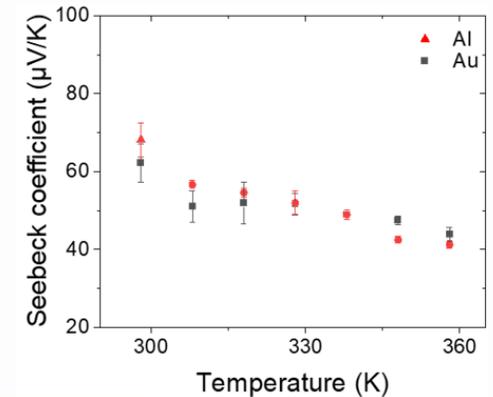
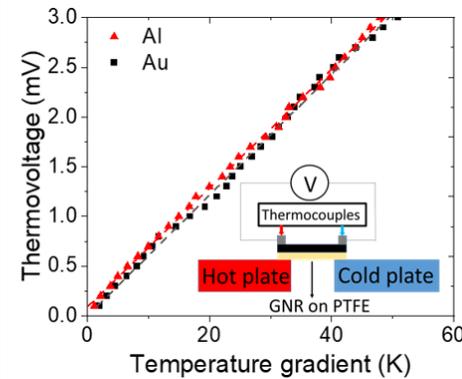
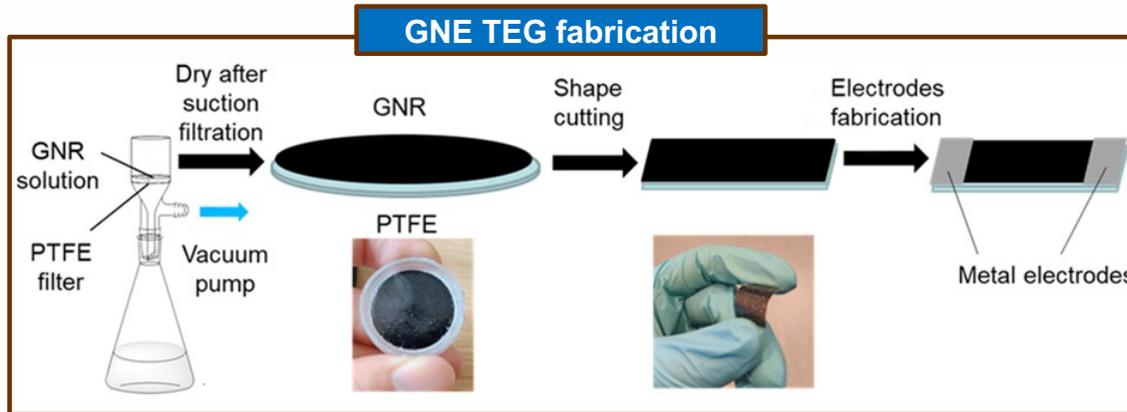
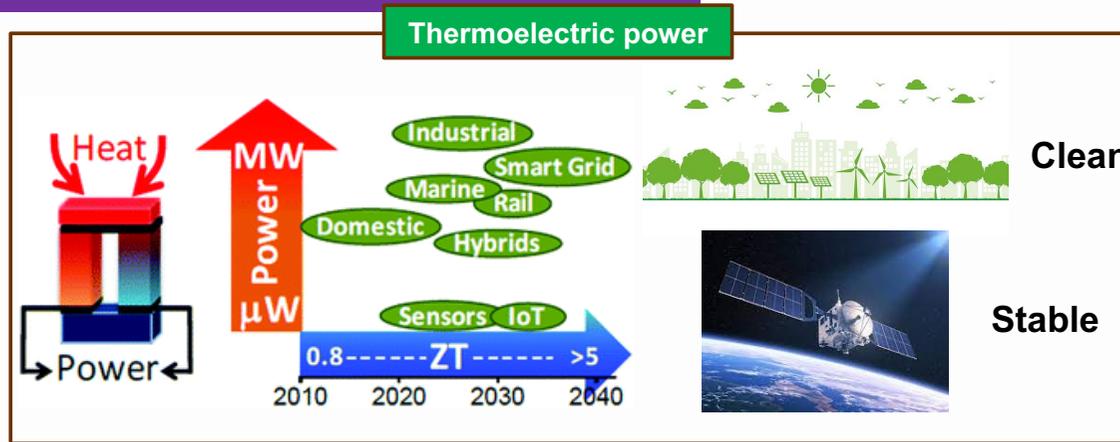
Comparison with literature



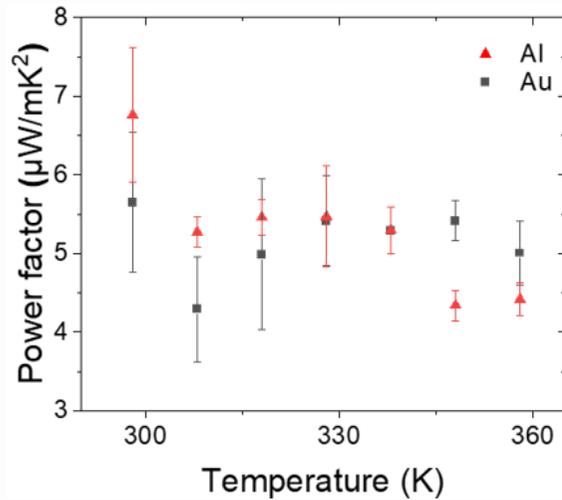
- GR QDs
- GR-Si
- ▲ GR-Si
- ▼ GR-Si
- ◆ GNR
- ▲ GR-InSb
- ▶ GR-Si
- GR-WS₂-Si
- ◆ GR-Si
- GR-ZnO-Si
- GR-Ge
- ◆ GR-Si
- GR-Al₂O₃-GaAs
- ▶ GR-Al₂O₃-GaAs
- ▲ GR-Si
- ▼ GR-Si-Perovskite QDs
- ★ This work

Highest responsivity and detectivity among graphene-based devices

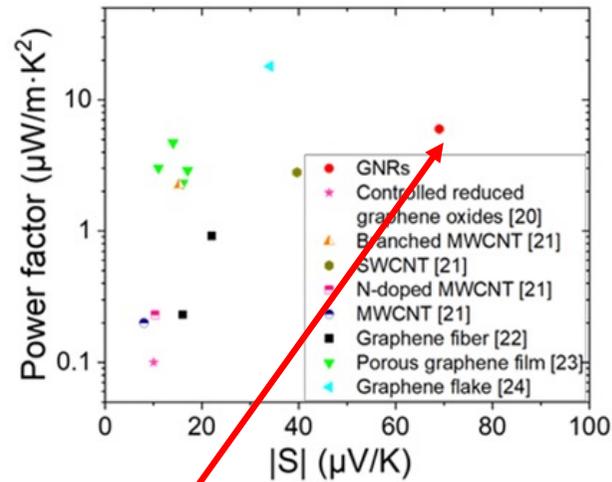
M.Y. Wang, *Nano Lett.* 24, 165 (2024)



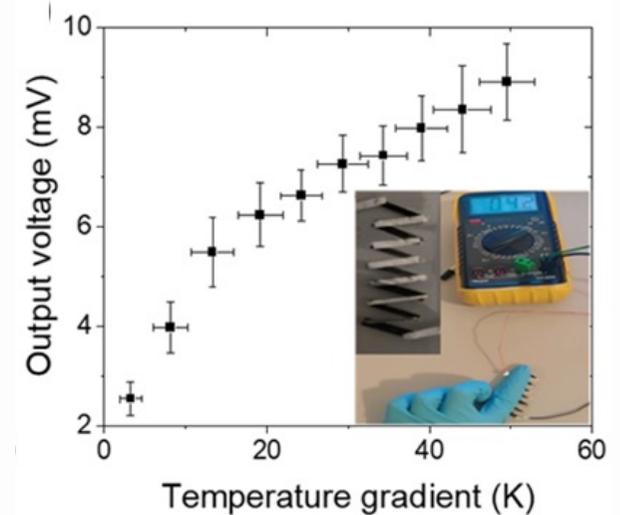
Average Seebeck coefficient $60 \mu\text{V/K}^{-1}$



Wei, et al., Carbon 210, 118053 (2023)



Highest Seebeck coefficient in carbon-based devices



- Flexible devices
- Body heat driven
- Voltage output ~ 10 mV

Summary

- ❖ **Background: Graphene too thin and not a semiconductor**
- ❖ **How to determine 2D material thickness?**
 - **Edge Rayleigh scattering+ dark field**
- ❖ **Graphene tunnelling transistors:**
 - **Unexpected size and geometry dependence**
- ❖ **Planar THz nanodevices:**
 - **Device that does not need a bandgap and zero threshold**
- ❖ **Semiconducting graphene nanoribbons**
 - **$E_g=1.8$ eV, high on/off FETs, photodiodes, thermoelectric generators**

Thank you!

